

# TMUX7219-Q1 具有 1.8V 逻辑电平和闩锁效应抑制特性的 44V 2:1 (SPDT) 精密开关

## 1 特性

- 符合面向汽车应用的 AEC-Q100 标准
  - 器件温度等级 1：-40°C 至 125°C 环境工作温度范围
- 功能安全型
  - 可提供用于功能安全系统设计的文档
- 闩锁效应抑制
- 双电源电压范围：±4.5V 至 ±22V
- 单电源电压范围：4.5V 至 44V
- 低导通电阻：2.1 Ω
- 低电荷注入：-10pC
- 大电流支持：330mA (最大值)
- 兼容 1.8V 逻辑电平
- 失效防护逻辑
- 轨到轨运行
- 双向信号路径
- 先断后合开关

## 2 应用

- 电动汽车充电站电源模块
- 高级驾驶辅助系统 (ADAS)
- 汽车网关
- 模拟和数字多路复用/多路信号分离
- 汽车音响主机
- 远程信息处理控制单元
- 紧急呼叫 (eCall)
- 信息娱乐系统
- 车身控制模块 (BCM)
- 车身电子装置和照明
- 电池管理系统 (BMS)
- HVAC 控制器模块
- ADAS 域控制器

## 3 说明

TMUX7219-Q1 是一款具有闩锁效应抑制特性的互补金属氧化物半导体 (CMOS) 开关，采用单通道 2:1 (SPDT) 配置。此器件在单电源 (4.5V 至 44V)、双电源 (±4.5V 至 ±22V) 或非对称电源 (例如  $V_{DD} = 12V$ ,  $V_{SS} = -5V$ ) 供电时均能正常运行。TMUX7219-Q1 可在源极 (Sx) 和漏极 (D) 引脚上支持从  $V_{SS}$  到  $V_{DD}$  范围的双向模拟和数字信号。

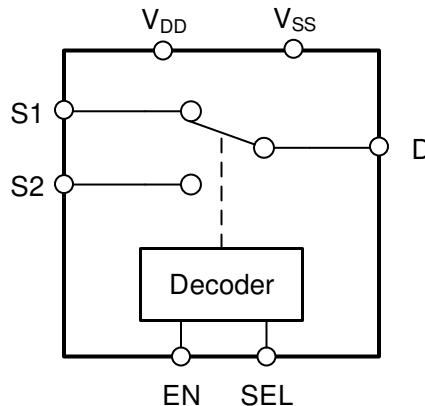
可以通过控制 EN 引脚来启用或禁用 TMUX7219-Q1。当禁用时，两个信号路径开关都被关闭。当启用时，SEL 引脚可用于打开信号路径 1 (S1 至 D) 或信号路径 2 (S2 至 D)。所有逻辑控制输入均支持 1.8 V 到  $V_{DD}$  的逻辑电平，因此，当器件在有效电源电压范围内运行时，可确保 TTL 和 CMOS 逻辑兼容性。失效防护逻辑电路允许先在控制引脚上施加电压，然后在电源引脚上施加电压，从而保护器件免受潜在的损害。

TMUX72xx 系列具有闩锁效应抑制特性，可防止器件内寄生结构之间通常由过压事件引起的大电流不良事件。闩锁状态通常会一直持续到电源轨关闭为止，并可能导致器件失效。闩锁效应抑制特性使得 TMUX72xx 系列开关和多路复用器能够在恶劣的环境中使用。

### 封装信息

器件型号	封装 <sup>(1)</sup>	本体尺寸 (标称值)
TMUX7219-Q1	VSSOP (8) DGK	3.00mm × 3.00mm

(1) 如需了解所有可用封装，请参阅数据表末尾的封装选项附录。



功能方框图



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## 4 Pin Configuration and Functions

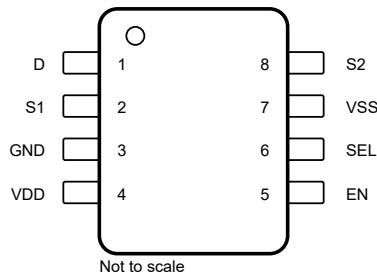


图 4-1. DGK Package, 8-Pin VSSOP (Top View)

表 4-1. Pin Functions

PIN		TYPE <sup>(1)</sup>	DESCRIPTION <sup>(2)</sup>
NAME	DGK		
D	1	I/O	Drain pin. Can be an input or output.
S1	2	I/O	Source pin 1. Can be an input or output.
GND	3	P	Ground (0 V) reference
V <sub>DD</sub>	4	P	Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 0.1 $\mu$ F to 10 $\mu$ F between V <sub>DD</sub> and GND.
EN	5	I	Active high logic enable, has internal pull-up resistor. When this pin is low, all switches are turned off. When this pin is high, the SEL logic input determine which switch is turned on.
SEL	6	I	Logic control input, has internal pull-down resistor. Controls the switch connection as shown in 节 7.5.
V <sub>SS</sub>	7	P	Negative power supply. This pin is the most negative power-supply potential. In single-supply applications, this pin can be connected to ground. For reliable operation, connect a decoupling capacitor ranging from 0.1 $\mu$ F to 10 $\mu$ F between V <sub>SS</sub> and GND.
S2	8	I/O	Source pin 2. Can be an input or output.
Thermal Pad	—	—	The thermal pad is not connected internally. There is no requirement to electrically connect this pad. If connected, it is recommended that the pad be left floating or tied to GND.

- (1) I = input, O = output, I/O = input and output, P = power.  
 (2) Refer to 节 7.4 for what to do with unused pins.

## 5 Specifications

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup> <sup>(2)</sup>

		MIN	MAX	UNIT
$V_{DD} - V_{SS}$	Supply voltage		48	V
$V_{BD}$		- 0.5	48	V
$V_{SS}$		- 48	0.5	V
$V_{SEL}$ or $V_{EN}$	Logic control input pin voltage (SEL, EN) <sup>(3)</sup>	- 0.5	48	V
$I_{SEL}$ or $I_{EN}$	Logic control input pin current (SEL, EN) <sup>(3)</sup>	- 30	30	mA
$V_S$ or $V_D$	Source or drain voltage (Sx, D) <sup>(3)</sup>	$V_{SS} - 0.5$	$V_{DD} + 0.5$	V
$I_{IK}$	Diode clamp current <sup>(3)</sup>	- 30	30	mA
$I_S$ or $I_D$ (CONT)	Source or drain continuous current (Sx, D)		$I_{DC} + 10\%$ <sup>(4)</sup>	mA
$T_A$	Ambient temperature	- 55	150	°C
$T_{stg}$	Storage temperature	- 65	150	°C
$T_J$	Junction temperature		150	°C
$P_{tot}$	Total power dissipation (DGK Package) <sup>(5)</sup>		460	mW

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) All voltages are with respect to ground, unless otherwise specified.
- (3) Pins are diode-clamped to the power-supply rails. Over voltage signals must be voltage and current limited to maximum ratings.
- (4) Refer to *Source or Drain Continuous Current* table for  $I_{DC}$  specifications.
- (5) For DGK package:  $P_{tot}$  derates linearly above  $T_A = 70^\circ\text{C}$  by  $6.7\text{mW}/^\circ\text{C}$ .

### 5.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001, all pins <sup>(1)</sup>	±2000
		Charged device model (CDM), ANSI/ESDA/ JEDEC JS-002, all pins <sup>(2)</sup>	±500

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 5.3 Thermal Information

THERMAL METRIC <sup>(1)</sup>		TMUX7219	UNIT
		DGK (VSSOP)	
		8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	152.1	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	48.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	73.2	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	4.1	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	71.8	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 5.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
$V_{DD} - V_{SS}$ <sup>(1)</sup>	Power supply voltage differential	4.5		44	V
$V_{DD}$	Positive power supply voltage	4.5		44	V
$V_S$ or $V_D$	Signal path input/output voltage (source or drain pin) (Sx, D)	$V_{SS}$		$V_{DD}$	V
$V_{SEL}$ or $V_{EN}$	Address or enable pin voltage	0		44	V
$I_S$ or $I_D$ (CONT)	Source or drain continuous current (Sx, D)			$I_{DC}$ <sup>(2)</sup>	mA
$T_A$	Ambient temperature	- 40		125	°C

(1)  $V_{DD}$  and  $V_{SS}$  can be any value as long as  $4.5\text{ V} \leq (V_{DD} - V_{SS}) \leq 44\text{ V}$ , and the minimum  $V_{DD}$  is met.

(2) Refer to *Source or Drain Continuous Current* table for  $I_{DC}$  specifications.

## 5.5 Source or Drain Continuous Current

at supply voltage of  $V_{DD} \pm 10\%$ ,  $V_{SS} \pm 10\%$  (unless otherwise noted)

CONTINUOUS CURRENT PER CHANNEL ( $I_{DC}$ )		$T_A = 25^\circ\text{C}$	$T_A = 85^\circ\text{C}$	$T_A = 125^\circ\text{C}$	UNIT
PACKAGE	TEST CONDITIONS				
DGK (VSSOP)	+44 V Single Supply <sup>(1)</sup>	330	210	120	mA
	$\pm 15\text{ V}$ Dual Supply	330	210	120	mA
	+12 V Single Supply	240	160	100	mA
	$\pm 5\text{ V}$ Dual Supply	240	160	100	mA
	+5 V Single Supply	180	120	80	mA

(1) Specified for nominal supply voltage only.

### 5.6 ±15 V Dual Supply: Electrical Characteristics

$V_{DD} = +15\text{ V} \pm 10\%$ ,  $V_{SS} = -15\text{ V} \pm 10\%$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +15\text{ V}$ ,  $V_{SS} = -15\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT	
<b>ANALOG SWITCH</b>								
$R_{ON}$	On-resistance	$V_S = -10\text{ V to }+10\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		2.1	2.9	$\Omega$	
			-40°C to +85°C			3.8	$\Omega$	
			-40°C to +125°C			4.5	$\Omega$	
$\Delta R_{ON}$	On-resistance mismatch between channels	$V_S = -10\text{ V to }+10\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.05	0.25	$\Omega$	
			-40°C to +85°C			0.3	$\Omega$	
			-40°C to +125°C			0.35	$\Omega$	
$R_{ON\ FLAT}$	On-resistance flatness	$V_S = -10\text{ V to }+10\text{ V}$ $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.5	0.6	$\Omega$	
			-40°C to +85°C			0.7	$\Omega$	
			-40°C to +125°C			0.85	$\Omega$	
$R_{ON\ DRIFT}$	On-resistance drift	$V_S = 0\text{ V}$ , $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	-40°C to +125°C		0.01		$\Omega/^\circ\text{C}$	
$I_{S(OFF)}$	Source off leakage current <sup>(1)</sup>	$V_{DD} = 16.5\text{ V}$ , $V_{SS} = -16.5\text{ V}$ Switch state is off $V_S = +10\text{ V} / -10\text{ V}$ $V_D = -10\text{ V} / +10\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-0.15	0.05	0.15	nA	
			-40°C to +85°C		-1.6		1.6	nA
			-40°C to +125°C		-15		15	nA
$I_{D(OFF)}$	Drain off leakage current <sup>(1)</sup>	$V_{DD} = 16.5\text{ V}$ , $V_{SS} = -16.5\text{ V}$ Switch state is off $V_S = +10\text{ V} / -10\text{ V}$ $V_D = -10\text{ V} / +10\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-1	0.05	1	nA	
			-40°C to +85°C		-3		3	nA
			-40°C to +125°C		-26		26	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current <sup>(2)</sup>	$V_{DD} = 16.5\text{ V}$ , $V_{SS} = -16.5\text{ V}$ Switch state is on $V_S = V_D = \pm 10\text{ V}$ Refer to <a href="#">On-Leakage Current</a>	25°C	-1	0.04	1	nA	
			-40°C to +85°C		-1.8		1.8	nA
			-40°C to +125°C		-18		18	nA
<b>LOGIC INPUTS (SEL / EN pins)</b>								
$V_{IH}$	Logic voltage high		-40°C to +125°C	1.3		44	V	
$V_{IL}$	Logic voltage low		-40°C to +125°C	0		0.8	V	
$I_{IH}$	Input leakage current		-40°C to +125°C		0.005	2	$\mu\text{A}$	
$I_{IL}$	Input leakage current		-40°C to +125°C	-1	-0.005		$\mu\text{A}$	
$C_{IN}$	Logic input capacitance		-40°C to +125°C		3		pF	
<b>POWER SUPPLY</b>								
$I_{DD}$	$V_{DD}$ supply current	$V_{DD} = 16.5\text{ V}$ , $V_{SS} = -16.5\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C		30	40	$\mu\text{A}$	
			-40°C to +85°C			48	$\mu\text{A}$	
			-40°C to +125°C			62	$\mu\text{A}$	
$I_{SS}$	$V_{SS}$ supply current	$V_{DD} = 16.5\text{ V}$ , $V_{SS} = -16.5\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C		3	10	$\mu\text{A}$	
			-40°C to +85°C			15	$\mu\text{A}$	
			-40°C to +125°C			25	$\mu\text{A}$	

(1) When  $V_S$  is positive,  $V_D$  is negative, or when  $V_S$  is negative,  $V_D$  is positive.

(2) When  $V_S$  is at a voltage potential,  $V_D$  is floating, or when  $V_D$  is at a voltage potential,  $V_S$  is floating.

## 5.7 ±15 V Dual Supply: Switching Characteristics

$V_{DD} = +15\text{ V} \pm 10\%$ ,  $V_{SS} = -15\text{ V} \pm 10\%$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +15\text{ V}$ ,  $V_{SS} = -15\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT
$t_{\text{TRAN}}$	Transition time from control input	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Transition Time</a>	25°C		120	175	ns
			-40°C to +85°C			190	ns
			-40°C to +125°C			210	ns
$t_{\text{ON (EN)}}$	Turn-on time from enable	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		100	170	ns
			-40°C to +85°C			185	ns
			-40°C to +125°C			200	ns
$t_{\text{OFF (EN)}}$	Turn-off time from enable	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		100	180	ns
			-40°C to +85°C			195	ns
			-40°C to +125°C			210	ns
$t_{\text{BBM}}$	Break-before-make time delay	$V_S = 10\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Break-Before-Make</a>	25°C		50		ns
			-40°C to +85°C	1			ns
			-40°C to +125°C	1			ns
$T_{\text{ON (VDD)}}$	Device turn on time ( $V_{DD}$ to output)	$V_{DD}$ rise time = 100ns $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on (VDD) Time</a>	25°C		0.19		ms
			-40°C to +85°C			0.2	ms
			-40°C to +125°C			0.2	ms
$t_{\text{PD}}$	Propagation delay	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Propagation Delay</a>	25°C		700		ps
$Q_{\text{INJ}}$	Charge injection	$V_D = 0\text{ V}$ , $C_L = 1\text{ nF}$ Refer to <a href="#">Charge Injection</a>	25°C		-10		pC
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-75		dB
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-55		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-117		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-106		dB
BW	-3dB Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ Refer to <a href="#">Bandwidth</a>	25°C		40		MHz
$I_L$	Insertion loss	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		-0.18		dB
ACPSRR	AC Power Supply Rejection Ratio	$V_{\text{PP}} = 0.62\text{ V}$ on $V_{DD}$ and $V_{SS}$ $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ Refer to <a href="#">ACPSRR</a>	25°C		-64		dB
THD+N	Total Harmonic Distortion + Noise	$V_{\text{PP}} = 15\text{ V}$ , $V_{\text{BIAS}} = 0\text{ V}$ $R_L = 10\text{ k}\Omega$ , $C_L = 5\text{ pF}$ , $f = 20\text{ Hz}$ to $20\text{ kHz}$ Refer to <a href="#">THD + Noise</a>	25°C		0.0005		%
$C_{\text{S(OFF)}}$	Source off capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		33		pF
$C_{\text{D(OFF)}}$	Drain off capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		48		pF
$C_{\text{S(ON)}}$ , $C_{\text{D(ON)}}$	On capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		148		pF

### 5.8 ±20 V Dual Supply: Electrical Characteristics

$V_{DD} = +20\text{ V} \pm 10\%$ ,  $V_{SS} = -20\text{ V} \pm 10\%$ , GND = 0 V (unless otherwise noted)

Typical at  $V_{DD} = +20\text{ V}$ ,  $V_{SS} = -20\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT	
<b>ANALOG SWITCH</b>								
$R_{ON}$	On-resistance	$V_S = -15\text{ V to }+15\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		1.9	2.7	$\Omega$	
			-40°C to +85°C			3.5	$\Omega$	
			-40°C to +125°C			4.2	$\Omega$	
$\Delta R_{ON}$	On-resistance mismatch between channels	$V_S = -15\text{ V to }+15\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.04	0.22	$\Omega$	
			-40°C to +85°C			0.28	$\Omega$	
			-40°C to +125°C			0.3	$\Omega$	
$R_{ON\ FLAT}$	On-resistance flatness	$V_S = -15\text{ V to }+15\text{ V}$ $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.3	0.75	$\Omega$	
			-40°C to +85°C			0.9	$\Omega$	
			-40°C to +125°C			1.2	$\Omega$	
$R_{ON\ DRIFT}$	On-resistance drift	$V_S = 0\text{ V}$ , $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	-40°C to +125°C		0.009		$\Omega/^\circ\text{C}$	
$I_{S(OFF)}$	Source off leakage current <sup>(1)</sup>	$V_{DD} = 22\text{ V}$ , $V_{SS} = -22\text{ V}$ Switch state is off $V_S = +15\text{ V} / -15\text{ V}$ $V_D = -15\text{ V} / +15\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-1.5	0.05	1.5	nA	
			-40°C to +85°C		-4		4	nA
			-40°C to +125°C		-24		24	nA
$I_{D(OFF)}$	Drain off leakage current <sup>(1)</sup>	$V_{DD} = 22\text{ V}$ , $V_{SS} = -22\text{ V}$ Switch state is off $V_S = +15\text{ V} / -15\text{ V}$ $V_D = -15\text{ V} / +15\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-2	0.1	2	nA	
			-40°C to +85°C		-8		8	nA
			-40°C to +125°C		-44		44	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current <sup>(2)</sup>	$V_{DD} = 22\text{ V}$ , $V_{SS} = -22\text{ V}$ Switch state is on $V_S = V_D = \pm 15\text{ V}$ Refer to <a href="#">On-Leakage Current</a>	25°C	-2	0.1	2	nA	
			-40°C to +85°C		-5		5	nA
			-40°C to +125°C		-29		29	nA
<b>LOGIC INPUTS (SEL / EN pins)</b>								
$V_{IH}$	Logic voltage high		-40°C to +125°C	1.3		44	V	
$V_{IL}$	Logic voltage low		-40°C to +125°C	0		0.8	V	
$I_{IH}$	Input leakage current		-40°C to +125°C		0.005	2	$\mu\text{A}$	
$I_{IL}$	Input leakage current		-40°C to +125°C	-1	-0.005		$\mu\text{A}$	
$C_{IN}$	Logic input capacitance		-40°C to +125°C		3		pF	
<b>POWER SUPPLY</b>								
$I_{DD}$	$V_{DD}$ supply current	$V_{DD} = 22\text{ V}$ , $V_{SS} = -22\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C		34	44	$\mu\text{A}$	
			-40°C to +85°C			50	$\mu\text{A}$	
			-40°C to +125°C			65	$\mu\text{A}$	
$I_{SS}$	$V_{SS}$ supply current	$V_{DD} = 22\text{ V}$ , $V_{SS} = -22\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C		4	9	$\mu\text{A}$	
			-40°C to +85°C			12	$\mu\text{A}$	
			-40°C to +125°C			25	$\mu\text{A}$	

(1) When  $V_S$  is positive,  $V_D$  is negative, or when  $V_S$  is negative,  $V_D$  is positive.

(2) When  $V_S$  is at a voltage potential,  $V_D$  is floating, or when  $V_D$  is at a voltage potential,  $V_S$  is floating.

## 5.9 ±20 V Dual Supply: Switching Characteristics

$V_{DD} = +20\text{ V} \pm 10\%$ ,  $V_{SS} = -20\text{ V} \pm 10\%$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +20\text{ V}$ ,  $V_{SS} = -20\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT
$t_{\text{TRAN}}$	Transition time from control input	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Transition Time</a>	25°C		110	175	ns
			-40°C to +85°C			190	ns
			-40°C to +125°C			205	ns
$t_{\text{ON (EN)}}$	Turn-on time from enable	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		110	170	ns
			-40°C to +85°C			185	ns
			-40°C to +125°C			200	ns
$t_{\text{OFF (EN)}}$	Turn-off time from enable	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		90	180	ns
			-40°C to +85°C			190	ns
			-40°C to +125°C			200	ns
$t_{\text{BBM}}$	Break-before-make time delay	$V_S = 10\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Break-Before-Make</a>	25°C		55		ns
			-40°C to +85°C		1		ns
			-40°C to +125°C		1		ns
$T_{\text{ON (VDD)}}$	Device turn on time ( $V_{DD}$ to output)	$V_{DD}$ rise time = 100ns $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on (VDD) Time</a>	25°C		0.18		ms
			-40°C to +85°C			0.2	ms
			-40°C to +125°C			0.2	ms
$t_{\text{PD}}$	Propagation delay	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Propagation Delay</a>	25°C		715		ps
$Q_{\text{INJ}}$	Charge injection	$V_D = 0\text{ V}$ , $C_L = 1\text{ nF}$ Refer to <a href="#">Charge Injection</a>	25°C		-15		pC
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-75		dB
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-55		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-117		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-106		dB
BW	-3dB Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , Refer to <a href="#">Bandwidth</a>	25°C		38		MHz
$I_L$	Insertion loss	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		-0.16		dB
ACPSRR	AC Power Supply Rejection Ratio	$V_{\text{PP}} = 0.62\text{ V}$ on $V_{DD}$ and $V_{SS}$ $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ Refer to <a href="#">ACPSRR</a>	25°C		-63		dB
THD+N	Total Harmonic Distortion + Noise	$V_{\text{PP}} = 20\text{ V}$ , $V_{\text{BIAS}} = 0\text{ V}$ $R_L = 10\text{ k}\Omega$ , $C_L = 5\text{ pF}$ , $f = 20\text{ Hz}$ to $20\text{ kHz}$ Refer to <a href="#">THD + Noise</a>	25°C		0.0005		%
$C_{\text{S(OFF)}}$	Source off capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		32		pF
$C_{\text{D(OFF)}}$	Drain off capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		45		pF
$C_{\text{S(ON)}}$ , $C_{\text{D(ON)}}$	On capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		146		pF

### 5.10 44 V Single Supply: Electrical Characteristics

$V_{DD} = +44\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +44\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT	
<b>ANALOG SWITCH</b>								
$R_{ON}$	On-resistance	$V_S = 0\text{ V to }40\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		2.2	2.8	$\Omega$	
			-40°C to +85°C			3.6	$\Omega$	
			-40°C to +125°C			4.2	$\Omega$	
$\Delta R_{ON}$	On-resistance mismatch between channels	$V_S = 0\text{ V to }40\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.1	0.2	$\Omega$	
			-40°C to +85°C			0.3	$\Omega$	
			-40°C to +125°C			0.35	$\Omega$	
$R_{ON\ FLAT}$	On-resistance flatness	$V_S = 0\text{ V to }40\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.2	1	$\Omega$	
			-40°C to +85°C			1.3	$\Omega$	
			-40°C to +125°C			1.5	$\Omega$	
$R_{ON\ DRIFT}$	On-resistance drift	$V_S = 22\text{ V}$ , $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	-40°C to +125°C		0.008		$\Omega/^\circ\text{C}$	
$I_{S(OFF)}$	Source off leakage current <sup>(1)</sup>	$V_{DD} = 44\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is off $V_S = 40\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / 40\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-5	0.05	5	nA	
			-40°C to +85°C		-10		10	nA
			-40°C to +125°C		-35		35	nA
$I_{D(OFF)}$	Drain off leakage current <sup>(1)</sup>	$V_{DD} = 44\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is off $V_S = 40\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / 40\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-8	0.05	8	nA	
			-40°C to +85°C		-12		12	nA
			-40°C to +125°C		-70		70	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current <sup>(2)</sup>	$V_{DD} = 44\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is on $V_S = V_D = 40\text{ V}$ or $1\text{ V}$ Refer to <a href="#">On-Leakage Current</a>	25°C	-8	0.05	8	nA	
			-40°C to +85°C		-10		10	nA
			-40°C to +125°C		-45		45	nA
<b>LOGIC INPUTS (SEL / EN pins)</b>								
$V_{IH}$	Logic voltage high		-40°C to +125°C	1.3		44	V	
$V_{IL}$	Logic voltage low		-40°C to +125°C	0		0.8	V	
$I_{IH}$	Input leakage current		-40°C to +125°C		0.005	2	$\mu\text{A}$	
$I_{IL}$	Input leakage current		-40°C to +125°C	-1	-0.005		$\mu\text{A}$	
$C_{IN}$	Logic input capacitance		-40°C to +125°C		3		pF	
<b>POWER SUPPLY</b>								
$I_{DD}$	$V_{DD}$ supply current	$V_{DD} = 44\text{ V}$ , $V_{SS} = 0\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C		17	50	$\mu\text{A}$	
			-40°C to +85°C			60	$\mu\text{A}$	
			-40°C to +125°C			75	$\mu\text{A}$	

(1) When  $V_S$  is 40V,  $V_D$  is 1V, or when  $V_S$  is 1V,  $V_D$  is 40V.

(2) When  $V_S$  is at a voltage potential,  $V_D$  is floating, or when  $V_D$  is at a voltage potential,  $V_S$  is floating.

## 5.11 44 V Single Supply: Switching Characteristics

$V_{DD} = +44\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +44\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT
$t_{\text{TRAN}}$	Transition time from control input	$V_S = 18\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Transition Time</a>	25°C		120	175	ns
			-40°C to +85°C			190	ns
			-40°C to +125°C			205	ns
$t_{\text{ON (EN)}}$	Turn-on time from enable	$V_S = 18\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		120	168	ns
			-40°C to +85°C			185	ns
			-40°C to +125°C			195	ns
$t_{\text{OFF (EN)}}$	Turn-off time from enable	$V_S = 18\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		120	180	ns
			-40°C to +85°C			200	ns
			-40°C to +125°C			205	ns
$t_{\text{BBM}}$	Break-before-make time delay	$V_S = 18\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Break-Before-Make</a>	25°C		45		ns
			-40°C to +85°C		1		ns
			-40°C to +125°C		1		ns
$T_{\text{ON (VDD)}}$	Device turn on time ( $V_{DD}$ to output)	$V_{DD}$ rise time = 1 $\mu\text{s}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on (VDD) Time</a>	25°C		0.15		ms
			-40°C to +85°C			0.17	ms
			-40°C to +125°C			0.17	ms
$t_{\text{PD}}$	Propagation delay	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Propagation Delay</a>	25°C		930		ps
$Q_{\text{INJ}}$	Charge injection	$V_D = 22\text{ V}$ , $C_L = 1\text{ nF}$ Refer to <a href="#">Charge Injection</a>	25°C		-16		pC
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-75		dB
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-55		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-117		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-106		dB
BW	-3dB Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ Refer to <a href="#">Bandwidth</a>	25°C		37		MHz
$I_L$	Insertion loss	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		-0.18		dB
ACPSRR	AC Power Supply Rejection Ratio	$V_{\text{PP}} = 0.62\text{ V}$ on $V_{DD}$ and $V_{SS}$ $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ Refer to <a href="#">ACPSRR</a>	25°C		-60		dB
THD+N	Total Harmonic Distortion + Noise	$V_{\text{PP}} = 22\text{ V}$ , $V_{\text{BIAS}} = 22\text{ V}$ $R_L = 10\text{ k}\Omega$ , $C_L = 5\text{ pF}$ , $f = 20\text{ Hz}$ to $20\text{ kHz}$ Refer to <a href="#">THD + Noise</a>	25°C		0.0004		%
$C_{\text{S(OFF)}}$	Source off capacitance	$V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		34		pF
$C_{\text{D(OFF)}}$	Drain off capacitance	$V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		48		pF
$C_{\text{S(ON)}}$ , $C_{\text{D(ON)}}$	On capacitance	$V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		146		pF

### 5.12 12 V Single Supply: Electrical Characteristics

$V_{DD} = +12\text{ V} \pm 10\%$ ,  $V_{SS} = 0\text{ V}$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +12\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT	
<b>ANALOG SWITCH</b>								
$R_{ON}$	On-resistance	$V_S = 0\text{ V to }10\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C	4.6	6		$\Omega$	
			-40°C to +85°C			7.5	$\Omega$	
			-40°C to +125°C			8.4	$\Omega$	
$\Delta R_{ON}$	On-resistance mismatch between channels	$V_S = 0\text{ V to }10\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C	0.08	0.2		$\Omega$	
			-40°C to +85°C			0.32	$\Omega$	
			-40°C to +125°C			0.35	$\Omega$	
$R_{ON\ FLAT}$	On-resistance flatness	$V_S = 0\text{ V to }10\text{ V}$ $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C	1.2	2		$\Omega$	
			-40°C to +85°C			2.2	$\Omega$	
			-40°C to +125°C			2.4	$\Omega$	
$R_{ON\ DRIFT}$	On-resistance drift	$V_S = 6\text{ V}$ , $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	-40°C to +125°C	0.017			$\Omega/^\circ\text{C}$	
$I_{S(OFF)}$	Source off leakage current <sup>(1)</sup>	$V_{DD} = 13.2\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is off $V_S = 10\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / 10\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-0.5	0.05	0.5	nA	
			-40°C to +85°C		-2		2	nA
			-40°C to +125°C		-12		12	nA
$I_{D(OFF)}$	Drain off leakage current <sup>(1)</sup>	$V_{DD} = 13.2\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is off $V_S = 10\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / 10\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-0.5	0.05	0.5	nA	
			-40°C to +85°C		-3		3	nA
			-40°C to +125°C		-23		23	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current <sup>(2)</sup>	$V_{DD} = 13.2\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is on $V_S = V_D = 10\text{ V or }1\text{ V}$ Refer to <a href="#">On-Leakage Current</a>	25°C	-1.5	0.05	1.5	nA	
			-40°C to +85°C		-3		3	nA
			-40°C to +125°C		-15		15	nA
<b>LOGIC INPUTS (SEL / EN pins)</b>								
$V_{IH}$	Logic voltage high		-40°C to +125°C	1.3		44	V	
$V_{IL}$	Logic voltage low		-40°C to +125°C	0		0.8	V	
$I_{IH}$	Input leakage current		-40°C to +125°C		0.005	2	$\mu\text{A}$	
$I_{IL}$	Input leakage current		-40°C to +125°C	-1	-0.005		$\mu\text{A}$	
$C_{IN}$	Logic input capacitance		-40°C to +125°C		3		pF	
<b>POWER SUPPLY</b>								
$I_{DD}$	$V_{DD}$ supply current	$V_{DD} = 13.2\text{ V}$ , $V_{SS} = 0\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C	10	35		$\mu\text{A}$	
			-40°C to +85°C			45	$\mu\text{A}$	
			-40°C to +125°C			55	$\mu\text{A}$	

(1) When  $V_S$  is 10V,  $V_D$  is 1V, or when  $V_S$  is 1V,  $V_D$  is 10V.

(2) When  $V_S$  is at a voltage potential,  $V_D$  is floating, or when  $V_D$  is at a voltage potential,  $V_S$  is floating.

### 5.13 12 V Single Supply: Switching Characteristics

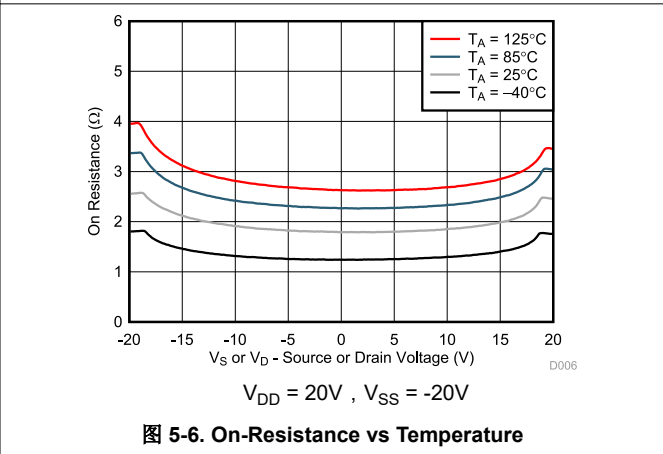
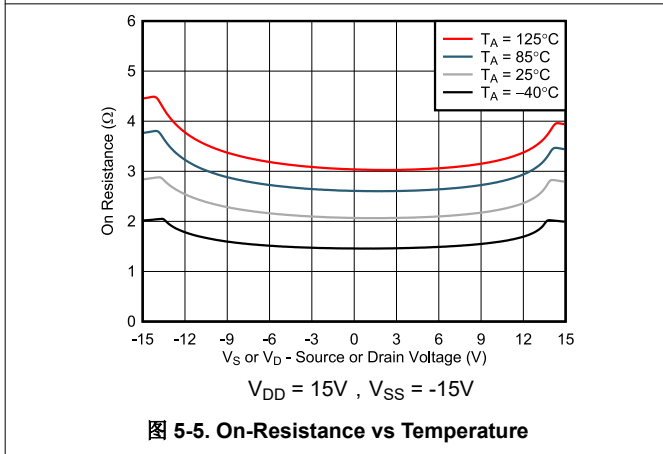
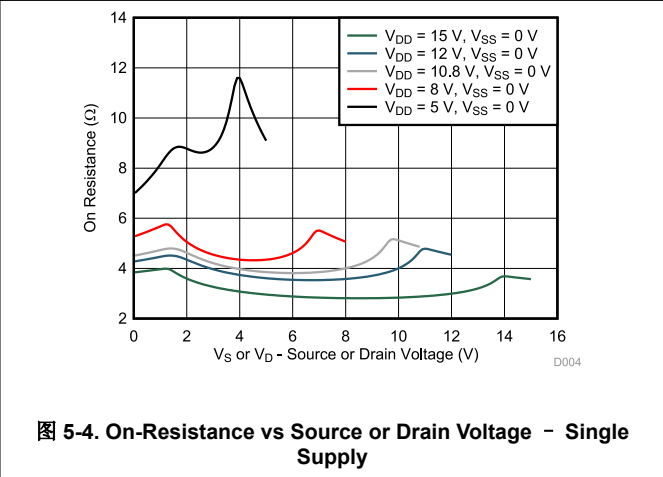
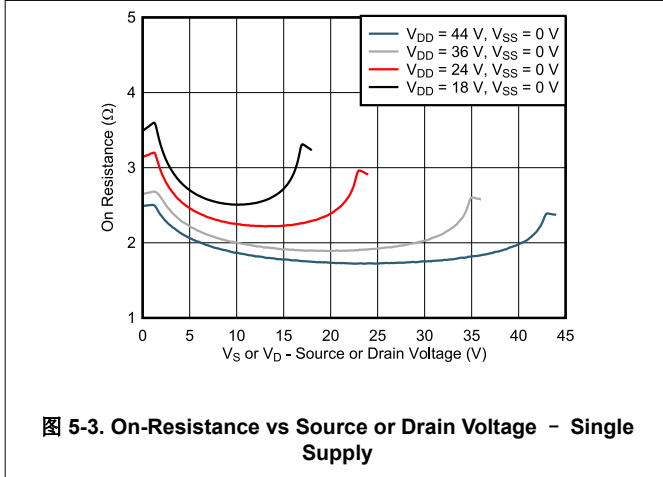
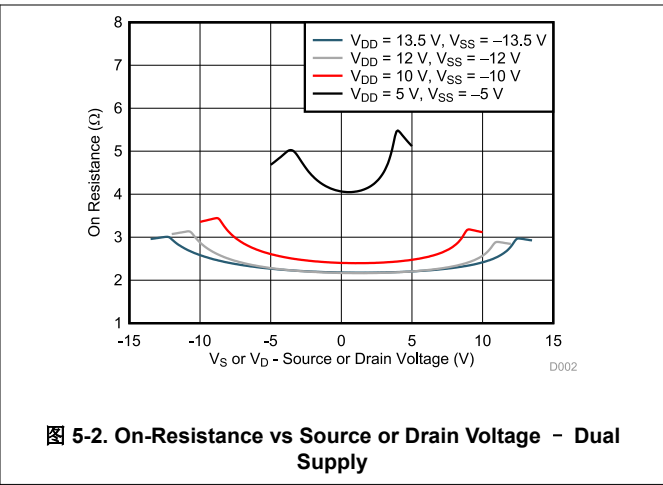
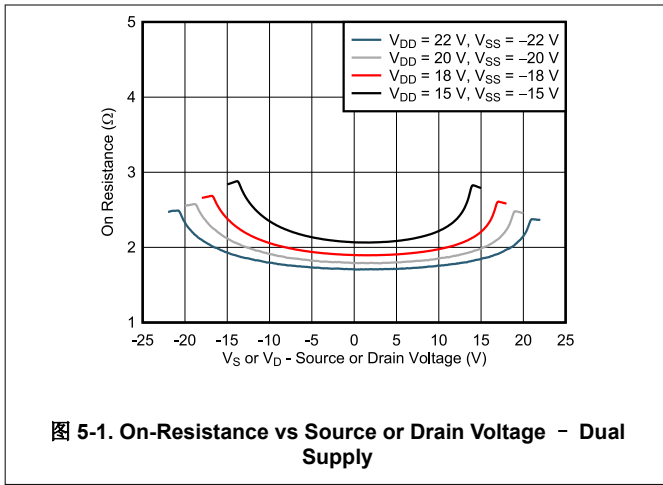
 $V_{DD} = +12\text{ V} \pm 10\%$ ,  $V_{SS} = 0\text{ V}$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

 Typical at  $V_{DD} = +12\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT
$t_{\text{TRAN}}$	Transition time from control input	$V_S = 8\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Transition Time</a>	25°C		180	185	ns
			-40°C to +85°C			215	ns
			-40°C to +125°C			235	ns
$t_{\text{ON (EN)}}$	Turn-on time from enable	$V_S = 8\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		120	180	ns
			-40°C to +85°C			210	ns
			-40°C to +125°C			230	ns
$t_{\text{OFF (EN)}}$	Turn-off time from enable	$V_S = 8\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		130	210	ns
			-40°C to +85°C			235	ns
			-40°C to +125°C			250	ns
$t_{\text{BBM}}$	Break-before-make time delay	$V_S = 8\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Break-Before-Make</a>	25°C		40		ns
			-40°C to +85°C		1		ns
			-40°C to +125°C		1		ns
$T_{\text{ON (VDD)}}$	Device turn on time ( $V_{DD}$ to output)	$V_{DD}$ rise time = 100ns $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on (VDD) Time</a>	25°C		0.19		ms
			-40°C to +85°C			0.2	ms
			-40°C to +125°C			0.2	ms
$t_{\text{PD}}$	Propagation delay	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Propagation Delay</a>	25°C		740		ps
$Q_{\text{INJ}}$	Charge injection	$V_D = 6\text{ V}$ , $C_L = 1\text{ nF}$ Refer to <a href="#">Charge Injection</a>	25°C		-6		pC
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-75		dB
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-55		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-117		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-106		dB
BW	-3dB Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ Refer to <a href="#">Bandwidth</a>	25°C		42		MHz
$I_L$	Insertion loss	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		-0.3		dB
ACPSRR	AC Power Supply Rejection Ratio	$V_{\text{PP}} = 0.62\text{ V}$ on $V_{DD}$ and $V_{SS}$ $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ Refer to <a href="#">ACPSRR</a>	25°C		-65		dB
THD+N	Total Harmonic Distortion + Noise	$V_{\text{PP}} = 6\text{ V}$ , $V_{\text{BIAS}} = 6\text{ V}$ $R_L = 10\text{ k}\Omega$ , $C_L = 5\text{ pF}$ , $f = 20\text{ Hz}$ to $20\text{ kHz}$ Refer to <a href="#">THD + Noise</a>	25°C		0.0009		%
$C_{\text{S(OFF)}}$	Source off capacitance	$V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		38		pF
$C_{\text{D(OFF)}}$	Drain off capacitance	$V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		56		pF
$C_{\text{S(ON)}}$ , $C_{\text{D(ON)}}$	On capacitance	$V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		150		pF

### 5.14 Typical Characteristics

at  $T_A = 25^\circ\text{C}$



### 5.14 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$

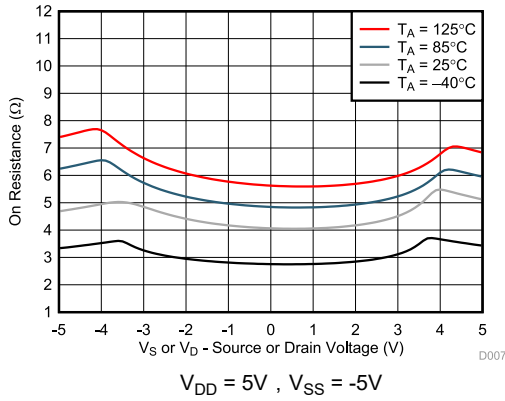


图 5-7. On-Resistance vs Temperature

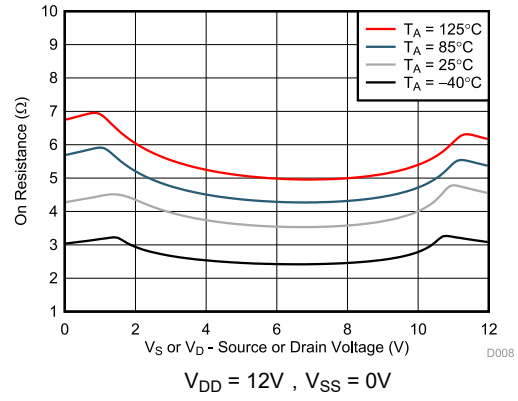


图 5-8. On-Resistance vs Temperature

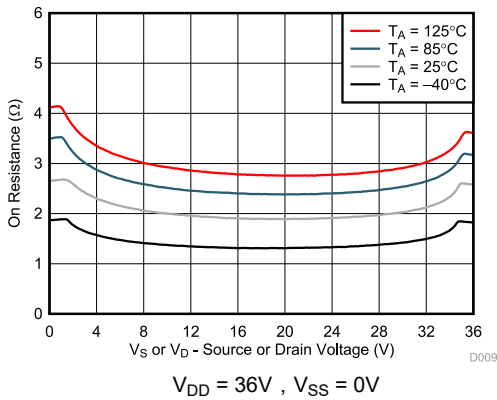


图 5-9. On-Resistance vs Temperature

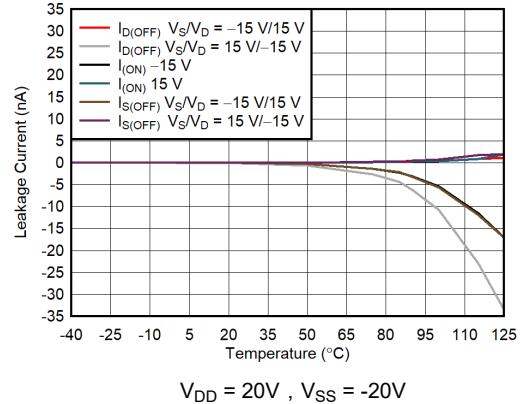


图 5-10. Leakage Current vs Temperature

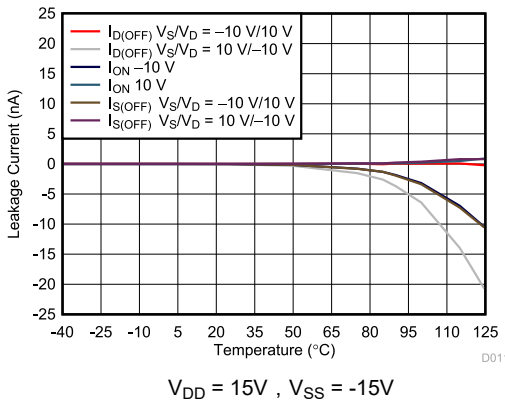


图 5-11. Leakage Current vs Temperature

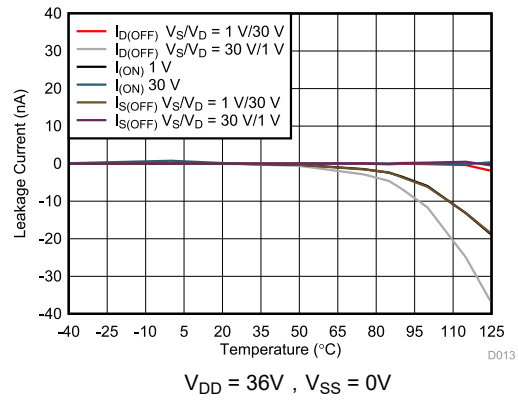


图 5-12. Leakage Current vs Temperature

### 5.14 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$

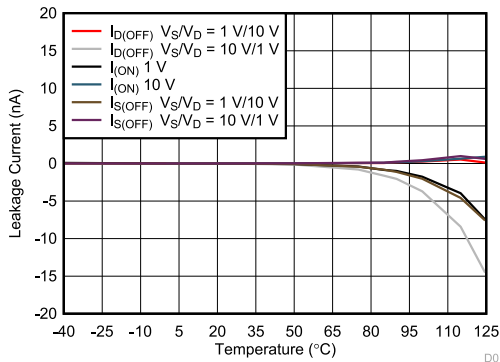


图 5-13. Leakage Current vs Temperature

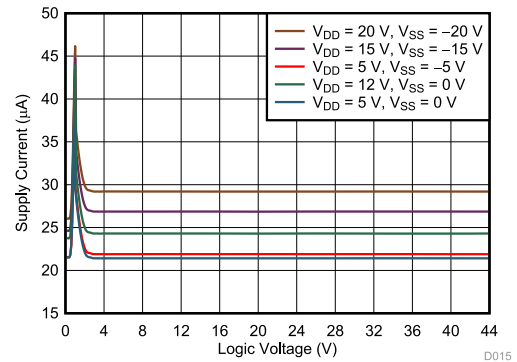


图 5-14. Supply Current vs Logic Voltage

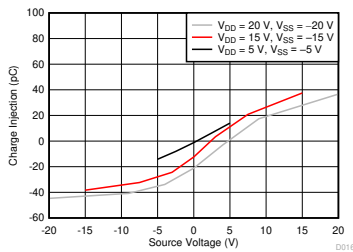


图 5-15. Charge Injection vs Source Voltage - Dual Supply

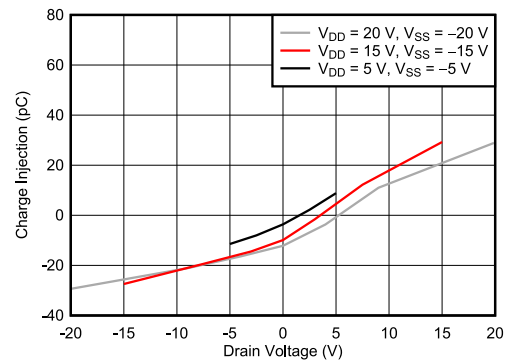


图 5-16. Charge Injection vs Drain Voltage - Dual Supply

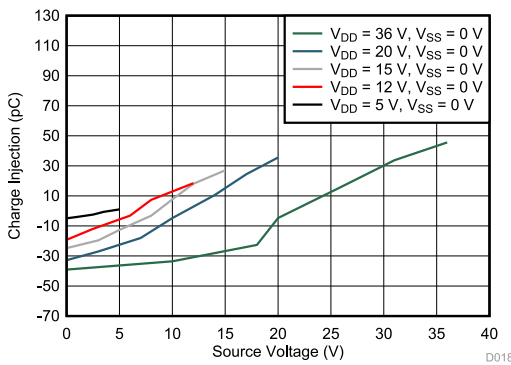


图 5-17. Charge Injection vs Source Voltage - Single Supply

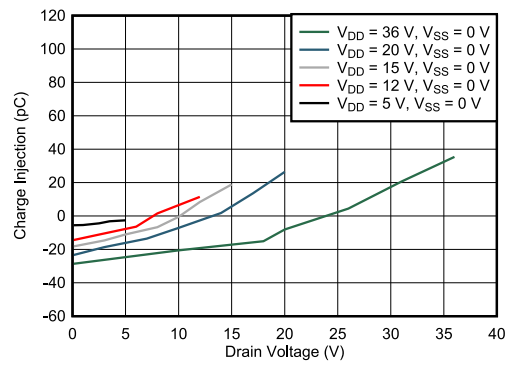
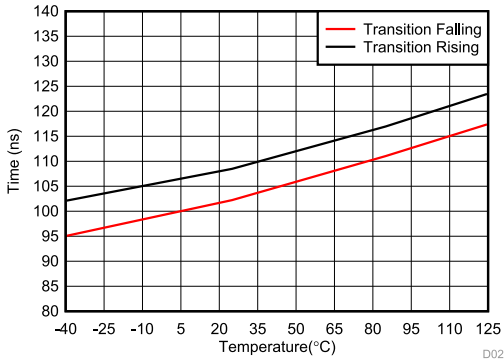


图 5-18. Charge Injection vs Drinan Voltage - Single Supply

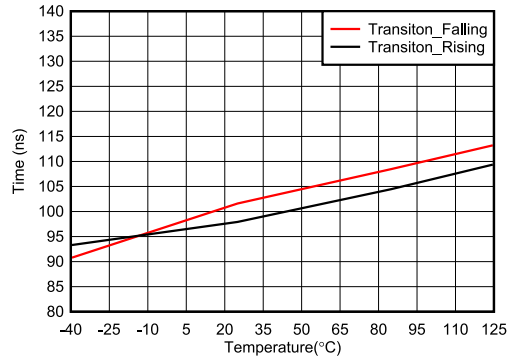
### 5.14 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$



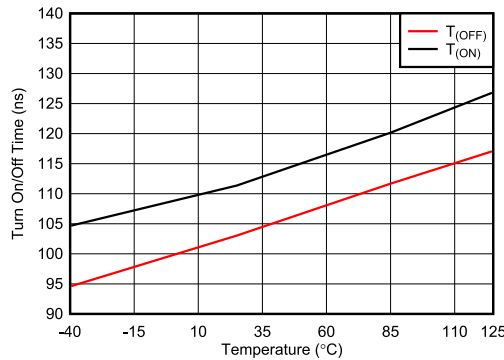
$V_{DD} = 15\text{V}, V_{SS} = -15\text{V}$

图 5-19.  $T_{\text{TRANSITION}}$  vs Temperature



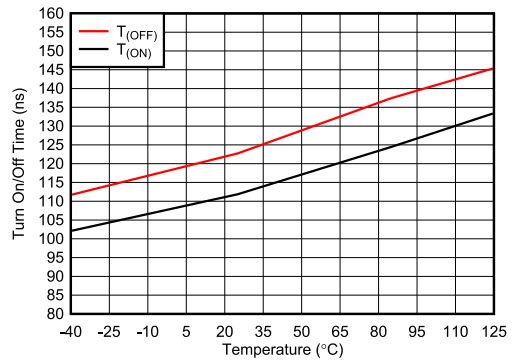
$V_{DD} = 44\text{V}, V_{SS} = 0\text{V}$

图 5-20.  $T_{\text{TRANSITION}}$  vs Temperature



$V_{DD} = 15\text{V}, V_{SS} = -15\text{V}$

图 5-21.  $T_{\text{ON}}$  and  $T_{\text{OFF}}$  vs Temperature



$V_{DD} = 44\text{V}, V_{SS} = 0\text{V}$

图 5-22.  $T_{\text{ON}}$  and  $T_{\text{OFF}}$  vs Temperature

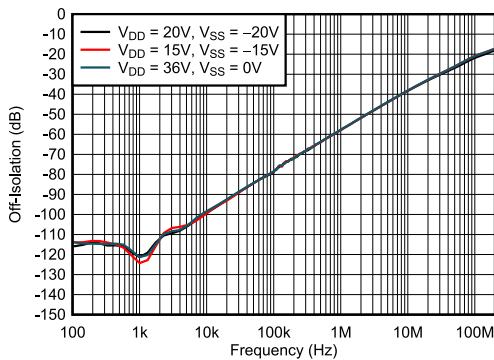
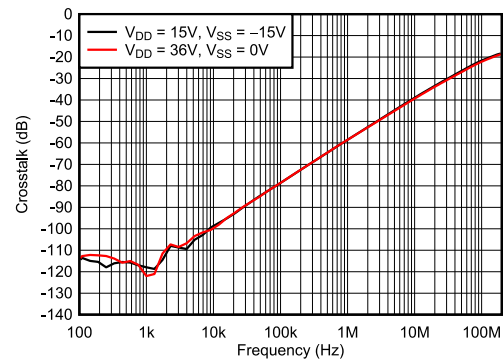


图 5-23. Off-Isolation vs Frequency

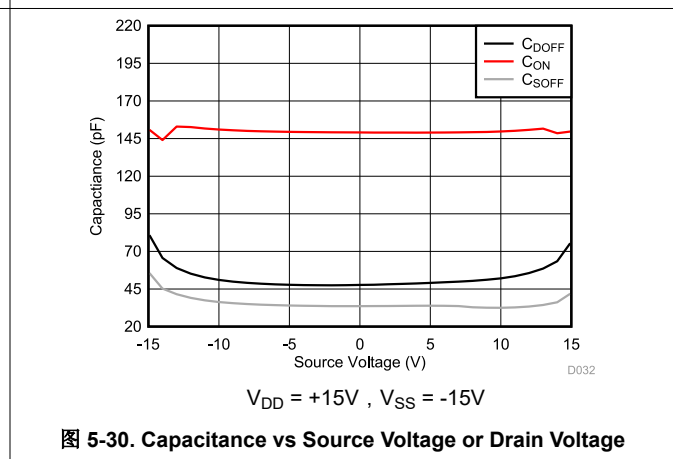
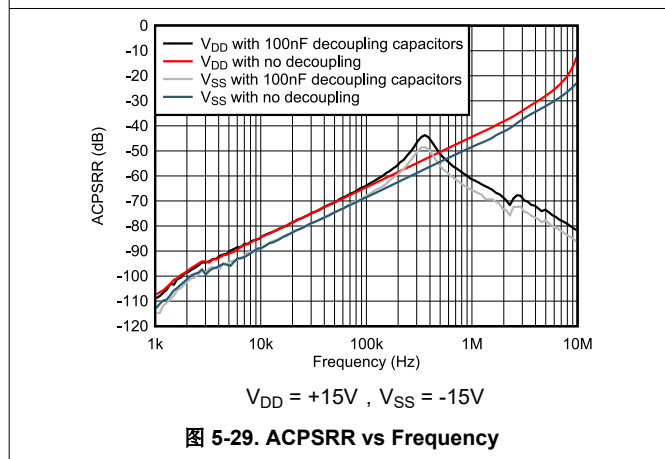
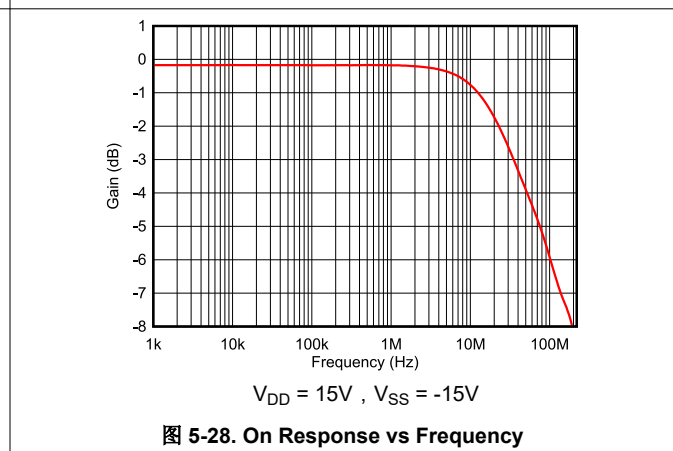
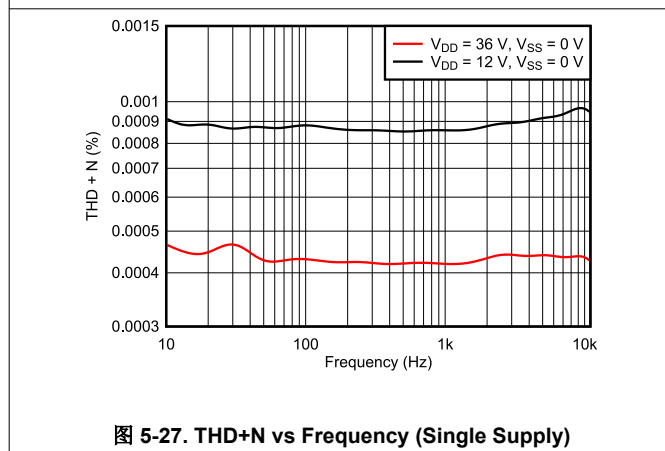
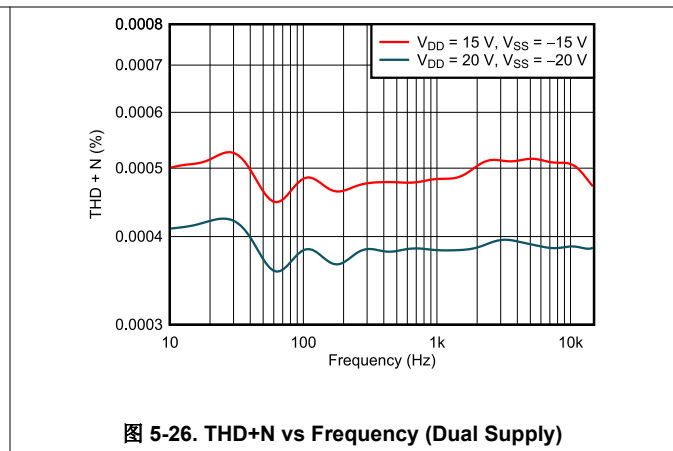
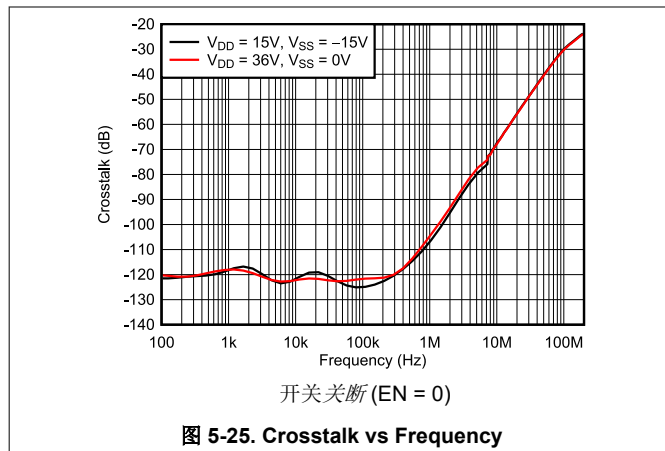


开关导通 (EN = 1)

图 5-24. Crosstalk vs Frequency

### 5.14 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$



### 5.14 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$

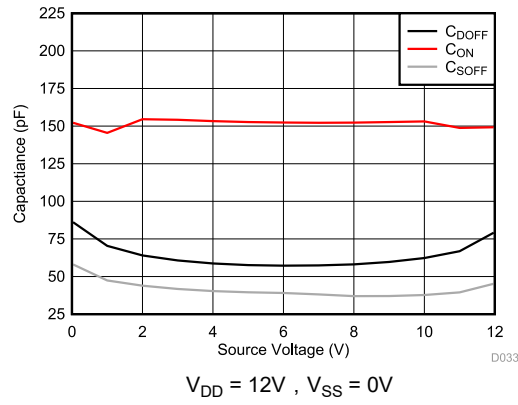


图 5-31. Capacitance vs Source Voltage or Drain Voltage

## 6 Parameter Measurement Information

### 6.1 On-Resistance

The on-resistance of a device is the ohmic resistance between the source (Sx) and drain (D) pins of the device. The on-resistance varies with input voltage and supply voltage. The symbol  $R_{ON}$  is used to denote on-resistance. 图 6-1 shows the measurement setup used to measure  $R_{ON}$ . Voltage (V) and current ( $I_{SD}$ ) are measured using the following setup, where  $R_{ON}$  is computed as  $R_{ON} = V / I_{SD}$ :

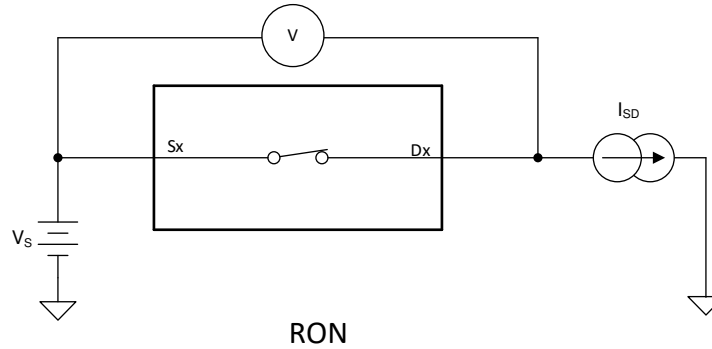


图 6-1. On-Resistance

### 6.2 Off-Leakage Current

There are two types of leakage currents associated with a switch during the off state:

1. Source off-leakage current.
2. Drain off-leakage current.

Source leakage current is defined as the leakage current flowing into or out of the source pin when the switch is off. This current is denoted by the symbol  $I_{S(OFF)}$ .

Drain leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is off. This current is denoted by the symbol  $I_{D(OFF)}$ .

图 6-2 shows the setup used to measure both off-leakage currents.

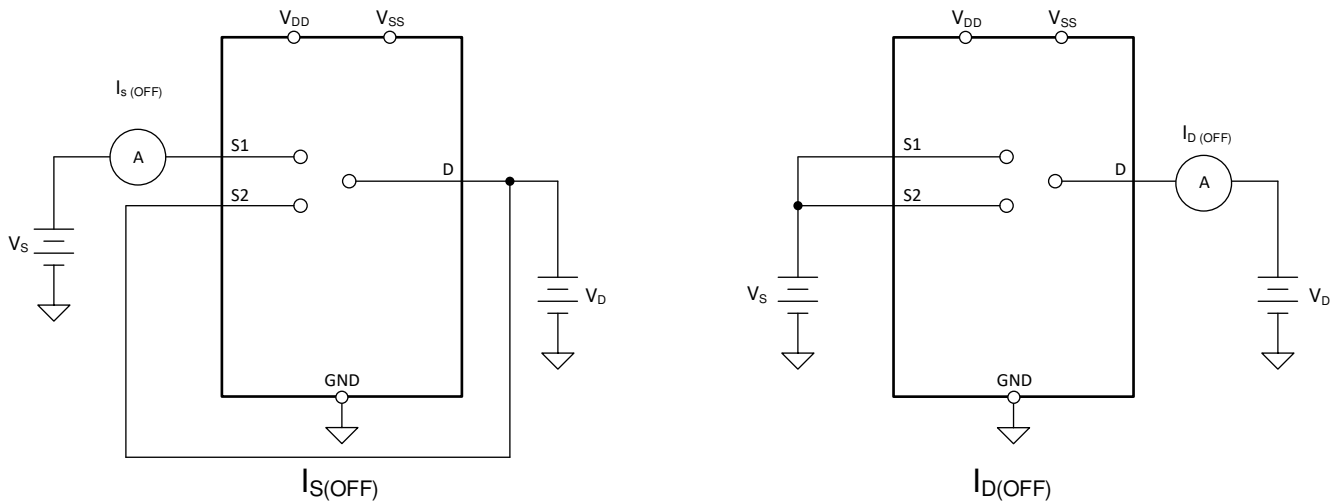


图 6-2. Off-Leakage Measurement Setup

### 6.3 On-Leakage Current

Source on-leakage current is defined as the leakage current flowing into or out of the source pin when the switch is on. This current is denoted by the symbol  $I_{S(ON)}$ .

Drain on-leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is on. This current is denoted by the symbol  $I_{D(ON)}$ .

Either the source pin or drain pin is left floating during the measurement. 图 6-3 shows the circuit used for measuring the on-leakage current, denoted by  $I_{S(ON)}$  or  $I_{D(ON)}$ .

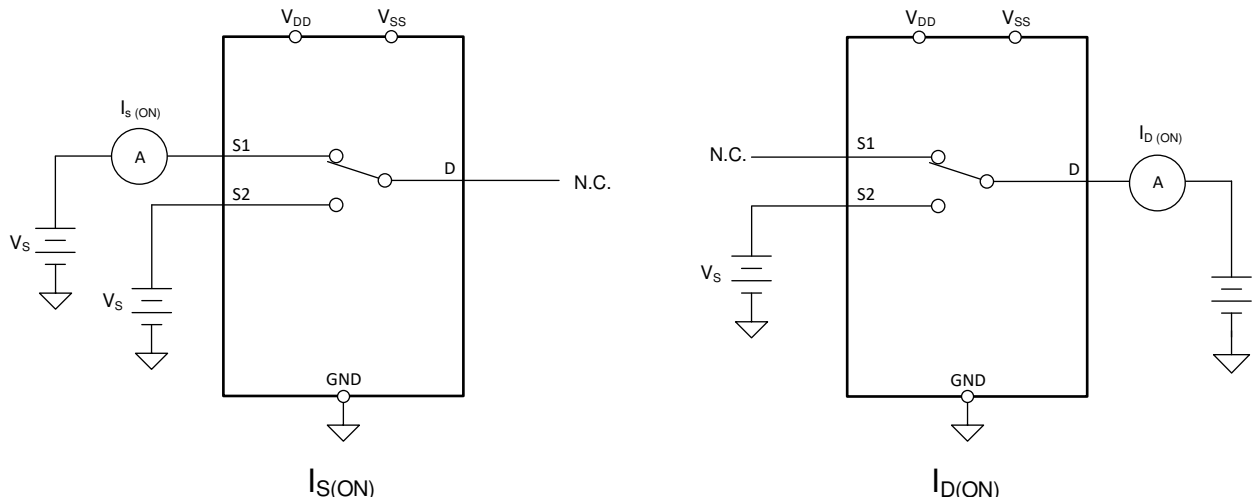


图 6-3. On-Leakage Measurement Setup

### 6.4 Transition Time

Transition time is defined as the time taken by the output of the device to rise or fall 90% after the address signal has risen or fallen past the logic threshold. The 90% transition measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. 图 6-4 shows the setup used to measure transition time, denoted by the symbol  $t_{TRANSITION}$ .

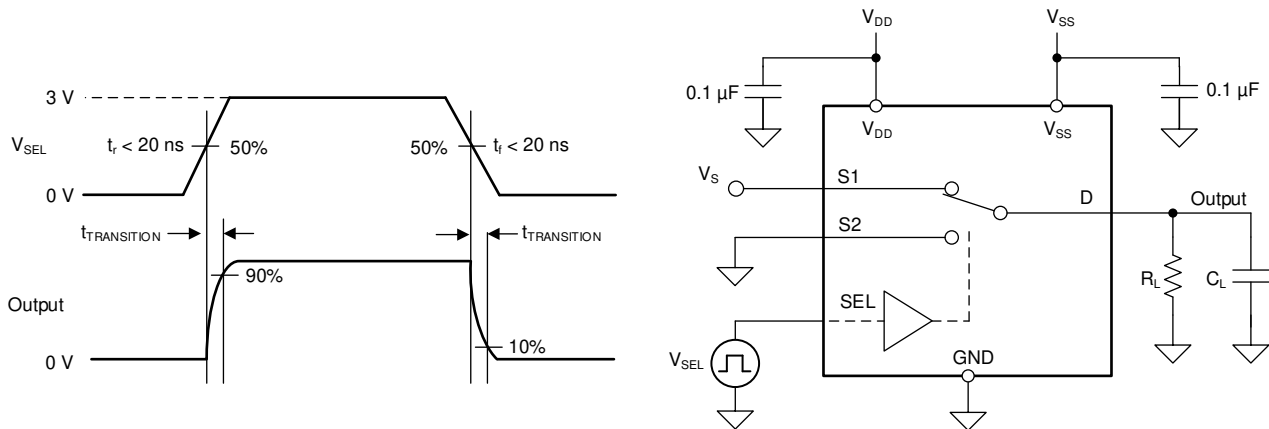
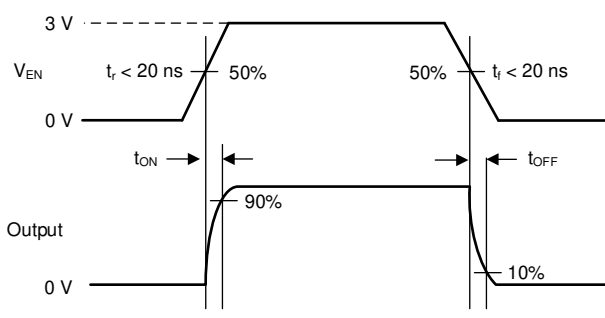
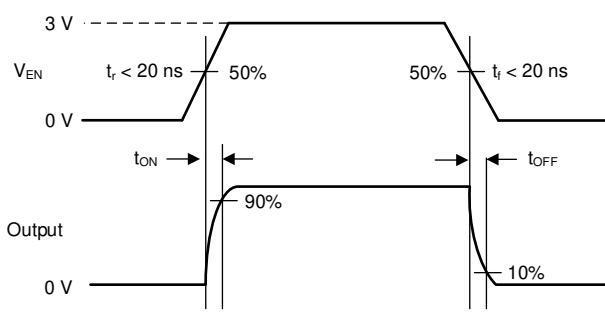


图 6-4. Transition-Time Measurement Setup

### 6.5 $t_{ON(EN)}$ and $t_{OFF(EN)}$

Turn-on time is defined as the time taken by the output of the device to rise to 90% after the enable has risen past the logic threshold. The 90% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance.  shows the setup used to measure turn-on time, denoted by the symbol  $t_{ON(EN)}$ .

Turn-off time is defined as the time taken by the output of the device to fall to 10% after the enable has fallen past the logic threshold. The 10% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance.  shows the setup used to measure turn-off time, denoted by the symbol  $t_{OFF(EN)}$ .

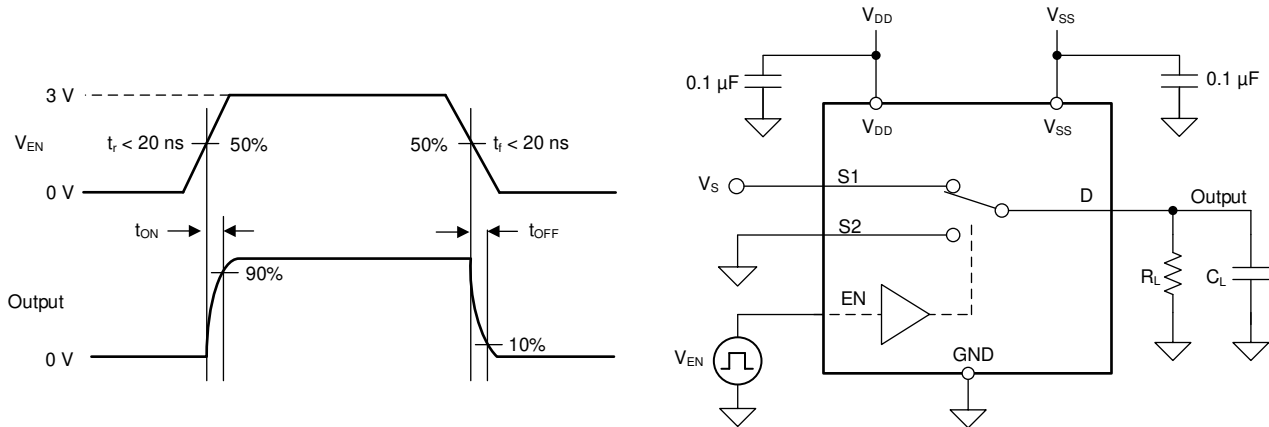
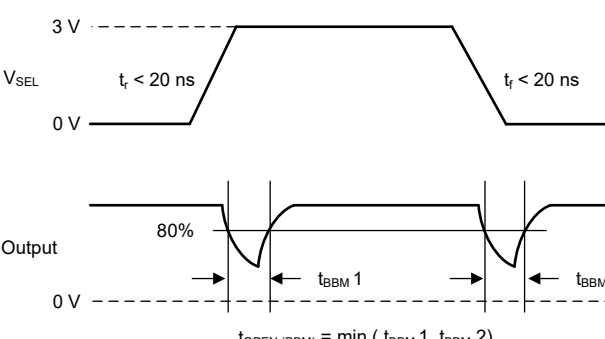


图 6-5. Turn-On and Turn-Off Time Measurement Setup

### 6.6 Break-Before-Make

Break-before-make delay is a safety feature that prevents two inputs from connecting when the device is switching. The output first breaks from the on-state switch before making the connection with the next on-state switch. The time delay between the *break* and the *make* is known as break-before-make delay.  shows the setup used to measure break-before-make delay, denoted by the symbol  $t_{OPEN(BBM)}$ .

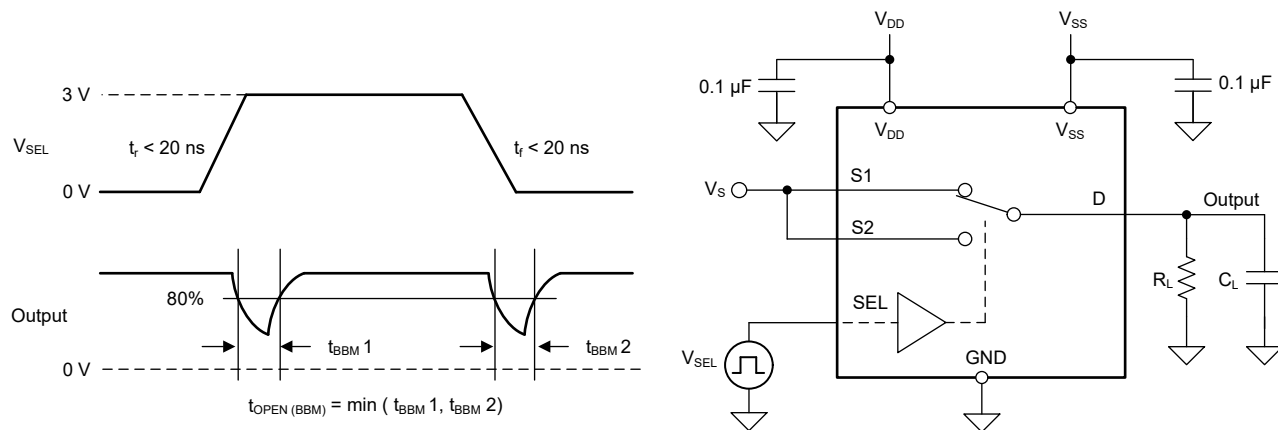


图 6-6. Break-Before-Make Delay Measurement Setup

### 6.7 $t_{ON(VDD)}$ Time

The  $t_{ON(VDD)}$  time is defined as the time taken by the output of the device to rise to 90% after the supply has risen past the supply threshold. The 90% measurement is used to provide the timing of the device turning on in the system. 图 6-7 shows the setup used to measure turn on time, denoted by the symbol  $t_{ON(VDD)}$ .

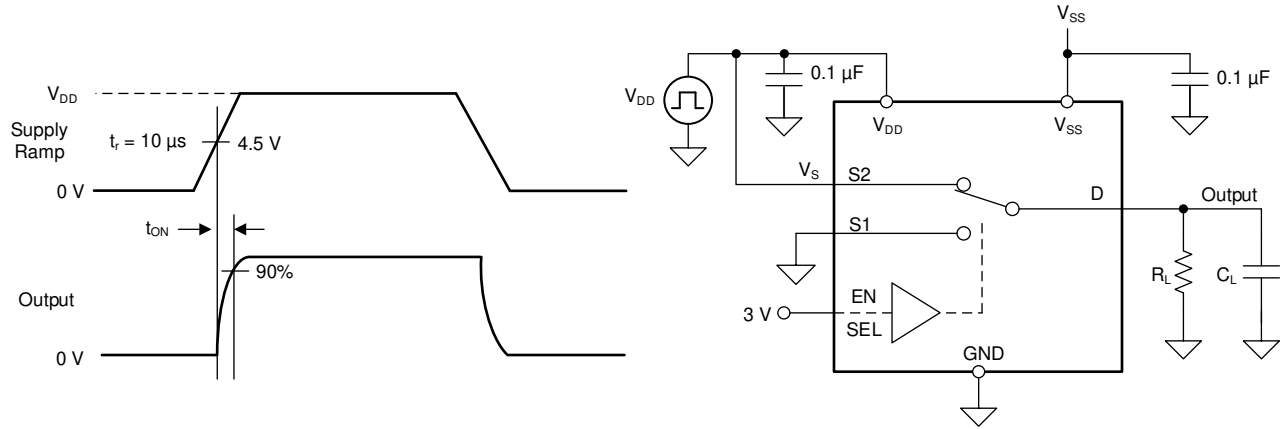


图 6-7.  $t_{ON(VDD)}$  Time Measurement Setup

### 6.8 Propagation Delay

Propagation delay is defined as the time taken by the output of the device to rise or fall 50% after the input signal has risen or fallen past the 50% threshold. 图 6-8 shows the setup used to measure propagation delay, denoted by the symbol  $t_{PD}$ .

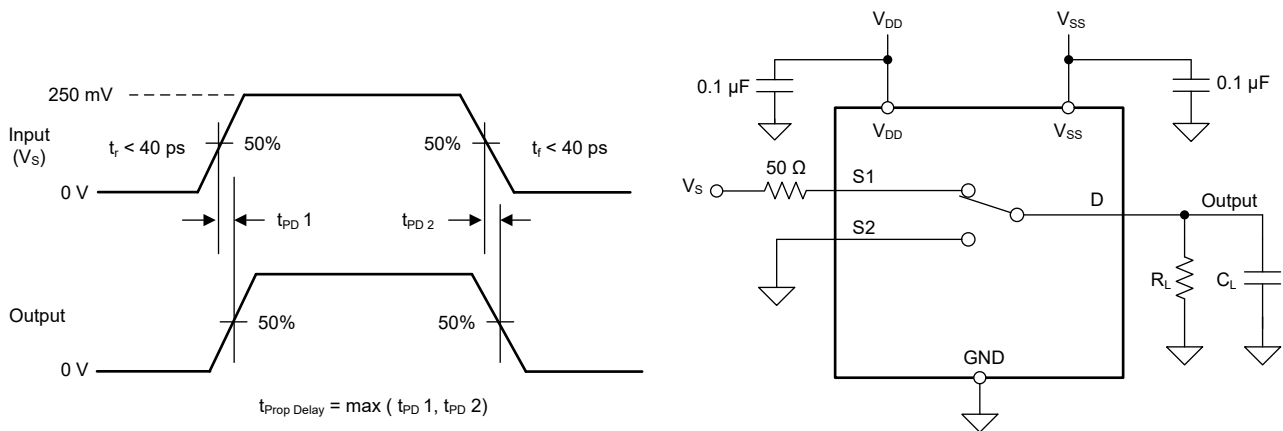


图 6-8. Propagation Delay Measurement Setup

### 6.9 Charge Injection

The TMUX7219-Q1 has a transmission-gate topology. Any mismatch in capacitance between the NMOS and PMOS transistors results in a charge injected into the drain or source during the falling or rising edge of the gate signal. The amount of charge injected into the source or drain of the device is known as charge injection, and is denoted by the symbol  $Q_C$ . 图 6-9 shows the setup used to measure charge injection from source (Sx) to drain (D).

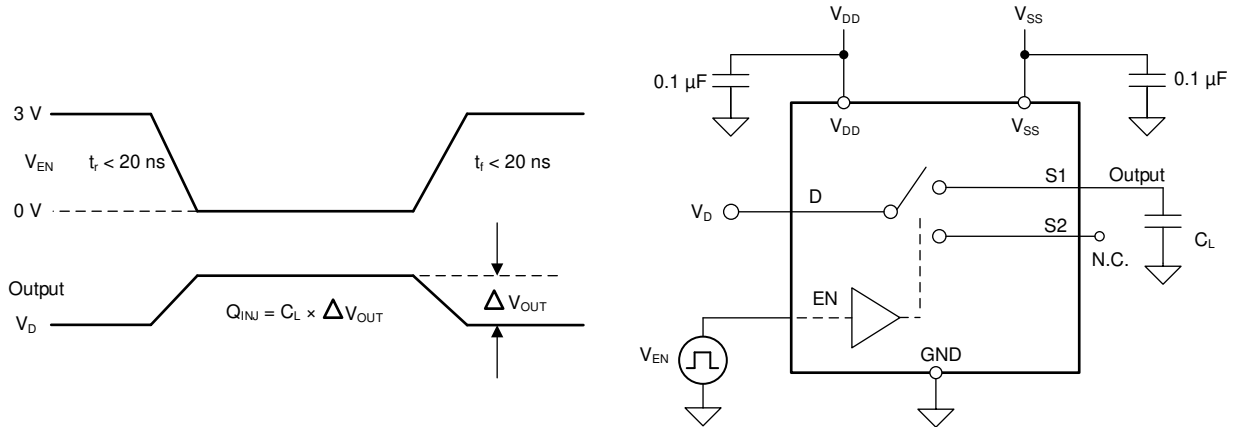
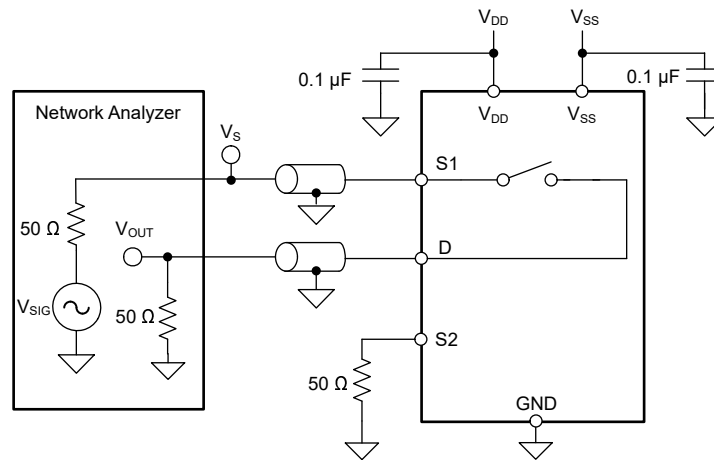


图 6-9. Charge-Injection Measurement Setup

### 6.10 Off Isolation

Off isolation is defined as the ratio of the signal at the drain pin (D) of the device when a signal is applied to the source pin (Sx) of an off-channel. 图 6-10 shows the setup used to measure, and the equation used to calculate off isolation.



$$\text{Off Isolation} = 20 \times \text{Log} \frac{V_{\text{OUT}}}{V_s}$$

图 6-10. Off Isolation Measurement Setup

### 6.11 Crosstalk

Crosstalk is defined as the ratio of the signal at the drain pin (D) of a different channel, when a signal is applied at the source pin (Sx) of an on-channel. 图 6-11 shows the setup used to measure, and the equation used to calculate crosstalk.

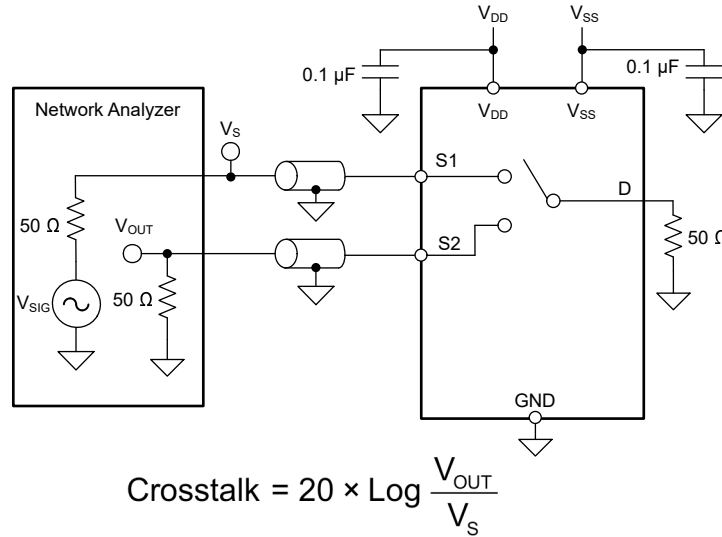


图 6-11. Crosstalk Measurement Setup

### 6.12 Bandwidth

Bandwidth is defined as the range of frequencies that are attenuated by less than 3 dB when the input is applied to the source pin (Sx) of an on-channel, and the output is measured at the drain pin (D) of the device. 图 6-12 shows the setup used to measure bandwidth.

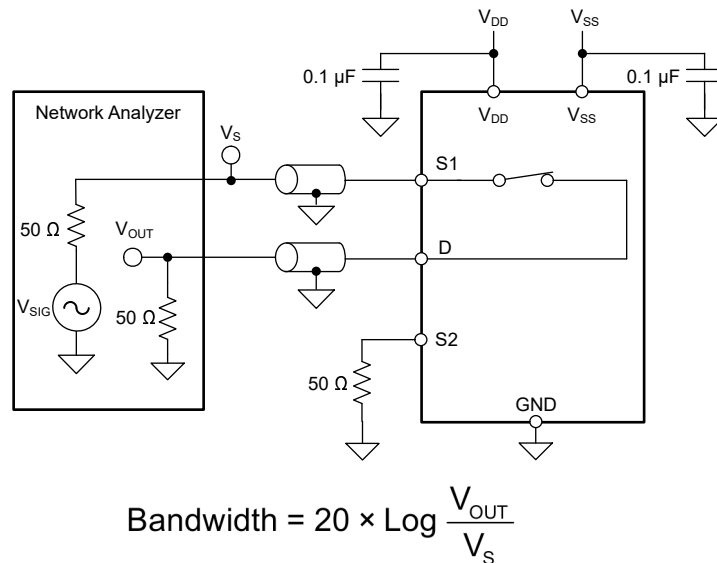


图 6-12. Bandwidth Measurement Setup

## 6.13 THD + Noise

The total harmonic distortion (THD) of a signal is a measurement of the harmonic distortion, and is defined as the ratio of the sum of the powers of all harmonic components to the power of the fundamental frequency at the mux output.

The on-resistance of the device varies with the amplitude of the input signal and results in distortion when the drain pin is connected to a low-impedance load. Total harmonic distortion plus noise is denoted as THD + N.

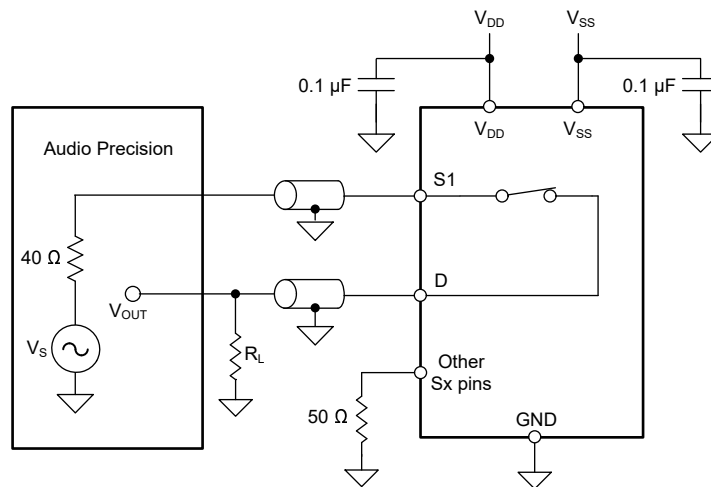
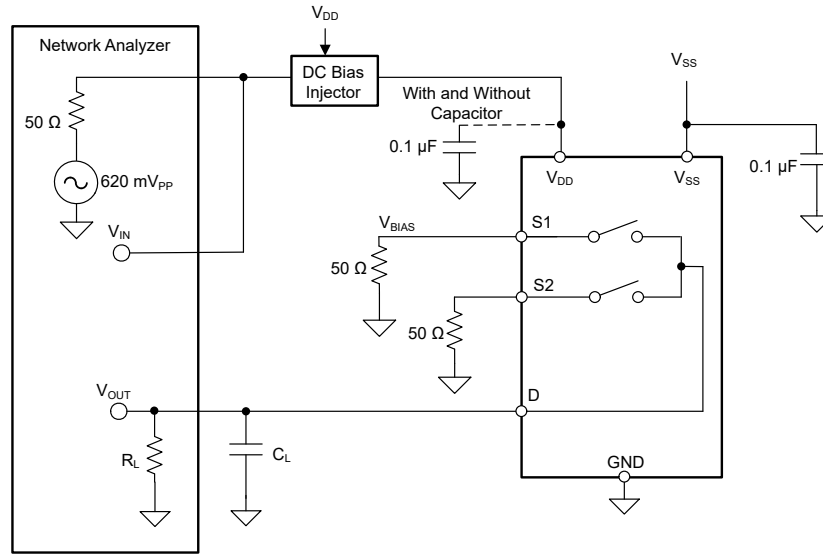


图 6-13. THD + N Measurement Setup

## 6.14 Power Supply Rejection Ratio (PSRR)

PSRR measures the ability of a device to prevent noise and spurious signals that appear on the supply voltage pin from coupling to the output of the switch. The DC voltage on the device supply is modulated by a sine wave of 620 mV<sub>PP</sub>. The ratio of the amplitude of signal on the output to the amplitude of the modulated signal is the ACPSRR. A high ratio represents a high degree of tolerance to supply rail variation.

This helps stabilize the supply and immediately filter as much of the supply noise as possible.



$$\text{PSRR} = 20 \times \text{Log} \frac{V_{\text{OUT}}}{V_{\text{IN}}}$$

图 6-14. ACPSRR Measurement Setup

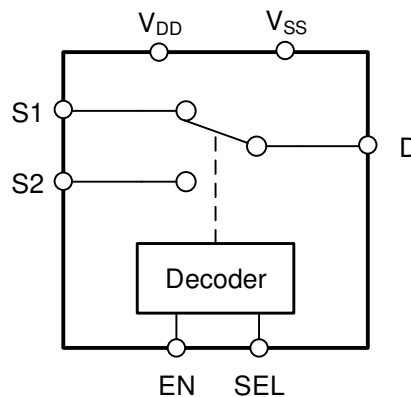
## 7 Detailed Description

### 7.1 Overview

The TMUX7219-Q1 is a 2:1, 1-channel switch. Each input is turned on or turned off based on the state of the select line and enable pin.

### 7.2 Functional Block Diagram

The following figure shows the functional block diagram of the TMUX7219-Q1.



### 7.3 Feature Description

#### 7.3.1 Bidirectional Operation

The TMUX7219-Q1 conducts equally well from source (Sx) to drain (D) or from drain (D) to source (Sx). Each channel has very similar characteristics in both directions and supports both analog and digital signals.

#### 7.3.2 Rail-to-Rail Operation

The valid signal path input and output voltage for TMUX7219-Q1 ranges from  $V_{SS}$  to  $V_{DD}$ .

### 7.3.3 1.8 V Logic Compatible Inputs

The TMUX7219-Q1 has 1.8 V logic compatible control for all logic control inputs. 1.8 V logic level inputs allows the device to interface with processors that have lower logic I/O rails and eliminates the need for an external translator, which saves both space and BOM cost. For more information on 1.8 V logic implementations refer to [Simplifying Design with 1.8 V logic Muxes and Switches](#).

### 7.3.4 Integrated Pull-Up and Pull-Down Resistor on Logic Pins

The TMUX7219-Q1 has internal weak pull-up and pull-down resistors to GND to ensure the logic pins are not left floating. The value of this pull-down resistor is approximately 4 M $\Omega$ , but is clamped to about 1  $\mu$ A at higher voltages. The EN pin integrates a pull-up resistor to V<sub>DD</sub> and the SEL pin integrates a pull-down resistor. This feature integrates up to two external components and reduces system size and cost.

### 7.3.5 Fail-Safe Logic

The TMUX7219-Q1 supports Fail-Safe Logic on the control input pins (EN and SEL) allowing for operation up to 44 V above ground, regardless of the state of the supply pins. This feature allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage. Fail-Safe Logic minimizes system complexity by removing the need for power supply sequencing on the logic control pins. For example, the Fail-Safe Logic feature allows the logic input pins of the TMUX7219-Q1 to be ramped to +44 V while V<sub>DD</sub> and V<sub>SS</sub> = 0 V. The logic control inputs are protected against positive faults of up to +44 V in powered-off condition, but do not offer protection against negative overvoltage conditions.

### 7.3.6 Latch-Up Immune

Latch-up is a condition where a low impedance path is created between a supply pin and ground. This condition is caused by a trigger (current injection or overvoltage), but once activated, the low impedance path remains even after the trigger is no longer present. This low impedance path may cause system upset or catastrophic damage due to excessive current levels. The latch-up condition typically requires a power cycle to eliminate the low impedance path.

The TMUX72xx-Q1 family of devices are constructed on Silicon on Insulator (SOI) based process where an oxide layer is added between the PMOS and NMOS transistor of each CMOS switch to prevent parasitic structures from forming. The oxide layer is also known as an insulating trench and prevents triggering of latch up events due to overvoltage or current injections. The latch-up immunity feature allows the TMUX72xx-Q1 family of switches and multiplexers to be used in harsh environments. For more information on latch-up immunity refer to [Using Latch Up Immune Multiplexers to Help Improve System Reliability](#).

### 7.3.7 Ultra-Low Charge Injection

图 7-1 shows how the TMUX7219-Q1 has a transmission gate topology. Any mismatch in the stray capacitance associated with the NMOS and PMOS causes an output level change whenever the switch is opened or closed.

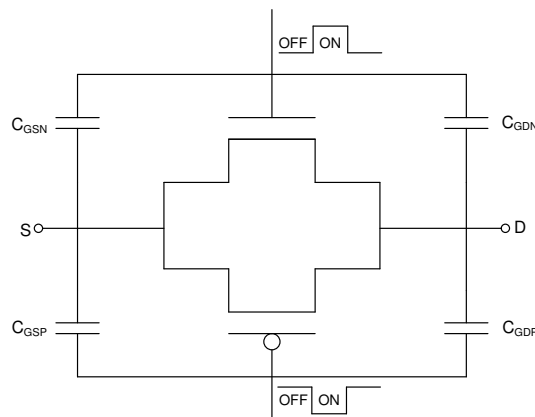

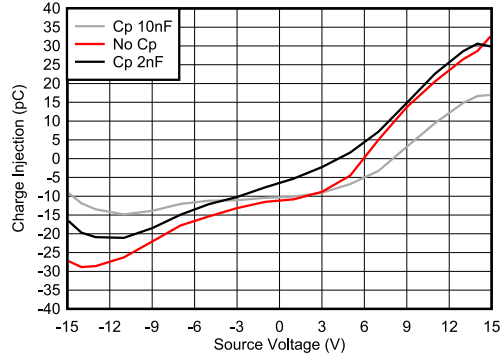


图 7-1. Transmission Gate Topology

The TMUX7219-Q1 contains specialized architecture to reduce charge injection on the source (Sx). To further reduce charge injection in a sensitive application, a compensation capacitor (Cp) can be added on the drain (D). This will ensure that excess charge from the switch transition will be pushed into the compensation capacitor on the drain (D) instead of the source (Sx). As a general rule, Cp should be 20× larger than the equivalent load capacitance on the source (Sx).  7-2 shows charge injection variation with source voltage with different compensation capacitors on the drain side.



** 7-2. Charge Injection Compensation**

## 7.4 Device Functional Modes

When the EN pin of the TMUX7219-Q1 is pulled high, one of the switches is closed based on the state of the SEL pin. When the EN pin is pulled low, both of the switches are in an open state regardless of the state of the SEL pin. The control pins can be as high as 44 V.

The TMUX7219-Q1 can operate without any external components except for the supply decoupling capacitors. The EN pin has an internal pull-up resistor of  $4\text{ M}\Omega$ , and SEL pin has internal pull-down resistor of  $4\text{ M}\Omega$ . If unused, EN pin must be tied to  $V_{DD}$  and SEL pin must be tied to GND to ensure the device does not consume additional current as highlighted in [Implications of Slow or Floating CMOS Inputs](#). Unused signal path inputs (S1, S2, or D) should be connected to GND.

## 7.5 Truth Tables

表 7-1 show the truth tables for the TMUX7219-Q1.

表 7-1. TMUX7219-Q1 Truth Table

EN	SEL	Selected Source Connected To Drain (D) Pin
0	X <sup>(1)</sup>	All sources are off (HI-Z)
1	0	S1
1	1	S2

(1) X denotes *do not care*.

## 8 Application and Implementation

### 备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

### 8.1 Application Information

TMUX7219-Q1 is part of the precision switches and multiplexers family of devices. TMUX7219-Q1 offers low RON, low on and off leakage currents, and ultra-low charge injection performance. These properties make TMUX7219-Q1 ideal for implementing high precision industrial systems requiring selection of one of two inputs or outputs.

### 8.2 Typical Applications

#### 8.2.1 Data Acquisition Calibration

One application of the TMUX7219-Q1 is in Data Acquisition systems (DAQ). To account for system loss and ensure the lowest possible noise floor, a calibration path is needed. To minimize board space and automate this procedure, many applications utilize a 2:1 (SPDT) switch. 图 8-1 shows the TMUX7219-Q1 configured for switching a calibration path on a precision measurement module.

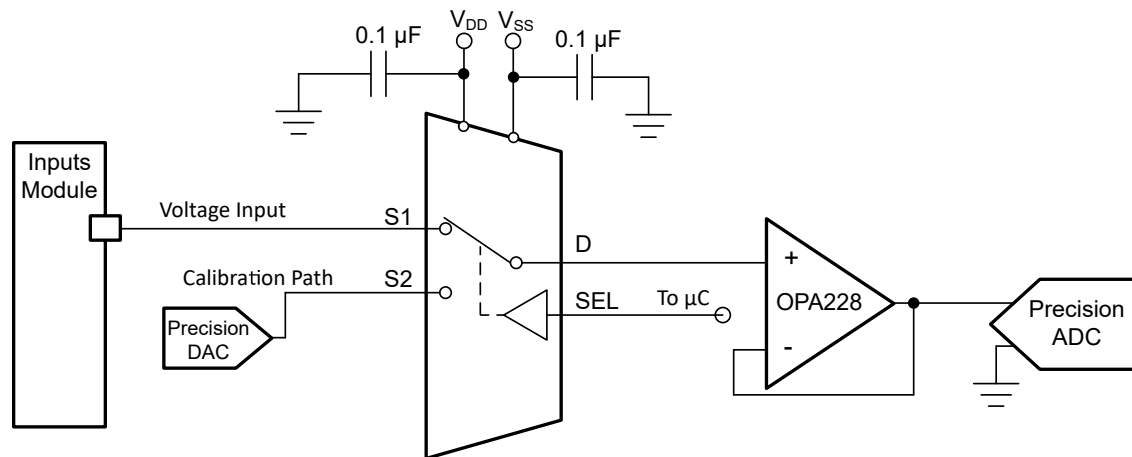


图 8-1. Calibration Path Switching for Data Acquisition

#### 8.2.2 Design Requirements

For the design example, use the parameters listed in 表 8-1.

表 8-1. Design Parameters

PARAMETERS	VALUES
Supply ( $V_{DD}$ )	12 V
Supply ( $V_{SS}$ )	-12 V
MUX I/O signal range	-12 V to 12 V (Rail-to-Rail)
Control logic thresholds	1.8 V compatible (up to $V_{DD}$ )
EN	EN pulled high to enable the switch

### 8.2.3 Detailed Design Procedure

The application shown in 图 8-1 demonstrates how to generate a  $\pm 12\text{V}$  PWM signal that is created by toggling the TMUX7219-Q1. This PWM signal generated by the EVSE on the control pilot line signals to the car the available current of the charger, and the car will respond with a charging status. This handshake results in a safe method for supplying power to vehicle. The TMUX7219-Q1 can support 1.8V logic signals on the control input, allowing the device to interface with low logic controls of an FPGA or MCU. The TMUX7219-Q1 can be operated without any external components except for the supply decoupling capacitors. The select pin has an internal pull-down resistor to prevent floating input logic. All inputs to the switch must fall within the recommend operating conditions of the TMUX7219-Q1 including signal range and continuous current. For this design with a positive supply of 12V on  $V_{DD}$ , and negative supply of  $-12\text{V}$  on  $V_{SS}$ , the signal range can be 12V to  $-12\text{V}$ . The max continuous current ( $I_{DC}$ ) can be up to 330mA as shown in 节 5.4 for wide-range current measurement.

### 8.3 Power Supply Recommendations

The TMUX7219-Q1 operates across a wide supply range of  $\pm 4.5\text{ V}$  to  $\pm 22\text{ V}$  (4.5 V to 44 V in single-supply mode). The device also performs well with asymmetrical supplies such as  $V_{DD} = 12\text{ V}$  and  $V_{SS} = -5\text{ V}$ .

Power-supply bypassing improves noise margin and prevents switching noise propagation from the supply rails to other components. Good power-supply decoupling is important to achieve optimum performance. For improved supply noise immunity, use a supply decoupling capacitor ranging from  $0.1\ \mu\text{F}$  to  $10\ \mu\text{F}$  at both the  $V_{DD}$  and  $V_{SS}$  pins to ground. Place the bypass capacitors as close to the power supply pins of the device as possible using low-impedance connections. TI recommends using multi-layer ceramic chip capacitors (MLCCs) that offer low equivalent series resistance (ESR) and inductance (ESL) characteristics for power-supply decoupling purposes. For very sensitive systems, or for systems in harsh noise environments, avoiding the use of vias for connecting the capacitors to the device pins may offer superior noise immunity. The use of multiple vias in parallel lowers the overall inductance and is beneficial for connections to ground and power planes. Always ensure the ground (GND) connection is established before supplies are ramped.

## 8.4 Layout

### 8.4.1 Layout Guidelines

When a PCB trace turns a corner at a  $90^\circ$  angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners. 图 8-2 shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.

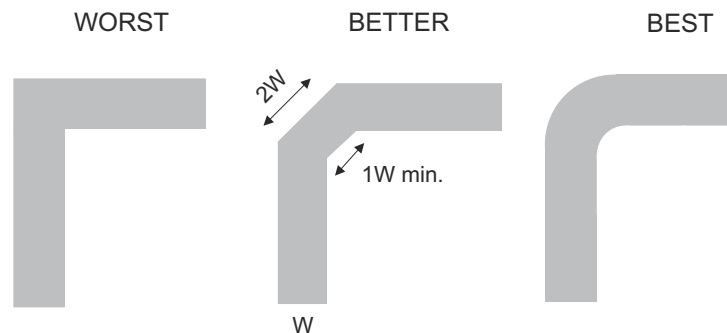


图 8-2. Trace Example

Route high-speed signals using a minimum of vias and corners which reduces signal reflections and impedance changes. When a via must be used, increase the clearance size around it to minimize its capacitance. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference

from the other layers of the board. Be careful when designing test points, through-hole pins are not recommended at high frequencies.

图 8-3 shows an example of a PCB layout with the TMUX7219-Q1. Some key considerations are as follows:

- For reliable operation, connect a decoupling capacitor ranging from 0.1  $\mu\text{F}$  to 10  $\mu\text{F}$  between VDD/VSS and GND. We recommend a 0.1  $\mu\text{F}$  and 1  $\mu\text{F}$  capacitor, placing the lowest value capacitor as close to the pin as possible. Make sure that the capacitor voltage rating is sufficient for the supply voltage.
- Keep the input lines as short as possible.
- Use a solid ground plane to help reduce electromagnetic interference (EMI) noise pickup.
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when necessary.
- Using multiple vias in parallel will lower the overall inductance and is beneficial for connection to ground planes.

### 8.4.2 Layout Example

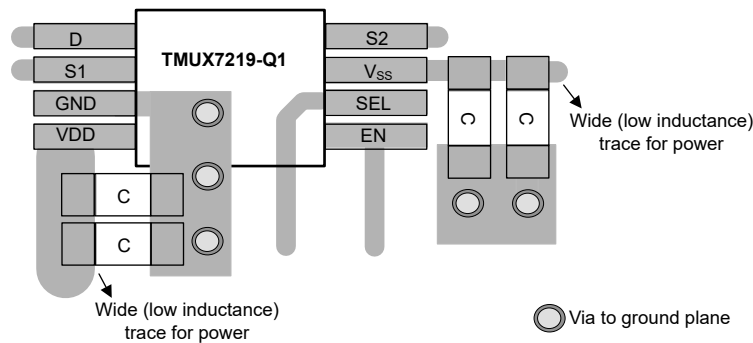


图 8-3. TMUX7219-Q1DGK Layout Example

## 9 Device and Documentation Support

### 9.1 Documentation Support

#### 9.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [Improve Stability Issues with Low CON Multiplexers](#) application brief
- Texas Instruments, [Improving Signal Measurement Accuracy in Automated Test Equipment](#) application brief
- Texas Instruments, [Multiplexers and Signal Switches Glossary](#) application report
- Texas Instruments, [QFN/SON PCB Attachment](#) application report
- Texas Instruments, [Quad Flatpack No-Lead Logic Packages](#) application report
- Texas Instruments, [Simplifying Design with 1.8 V logic Muxes and Switches](#) application brief
- Texas Instruments, [System-Level Protection for High-Voltage Analog Multiplexers](#) application report
- Texas Instruments, [TMUX7219-Q1 Functional Safety, FIT Rate, Failure Mode Distribution and Pin FMA](#) functional safety FIT rate, FMD and Pin-FMA

### 9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 9.3 支持资源

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链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的[使用条款](#)。

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ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

### 9.6 术语表

TI 术语表 本术语表列出并解释了术语、首字母缩略词和定义。

## 10 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision B (July 2024) to Revision C (December 2024)	Page
• 删除了整个数据表中对 RQX 封装的所有提及.....	1
• Added the <i>Integrated Pull-Down Resistor on Logic Pins</i> section.....	28

Changes from Revision A (June 2021) to Revision B (July 2024)	Page
• Updated IIH specification.....	6

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<b>Changes from Revision * (January 2021) to Revision A (June 2021)</b>	<b>Page</b>
• 将数据表的状态从预告信息 更改为量产数据 .....	<b>1</b>

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## **11 Mechanical, Packaging, and Orderable Information**

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">TMUX7219DGKRQ1</a>	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	(X219, X219Q) Q
TMUX7219DGKRQ1.B	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	(X219, X219Q) Q

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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**OTHER QUALIFIED VERSIONS OF TMUX7219-Q1 :**

- Catalog : [TMUX7219](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMUX7219DGKRQ1	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
TMUX7219DGKRQ1	VSSOP	DGK	8	2500	330.0	12.4	5.25	3.35	1.25	8.0	12.0	Q1

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TMUX7219DGKRQ1	VSSOP	DGK	8	2500	353.0	353.0	32.0
TMUX7219DGKRQ1	VSSOP	DGK	8	2500	366.0	364.0	50.0

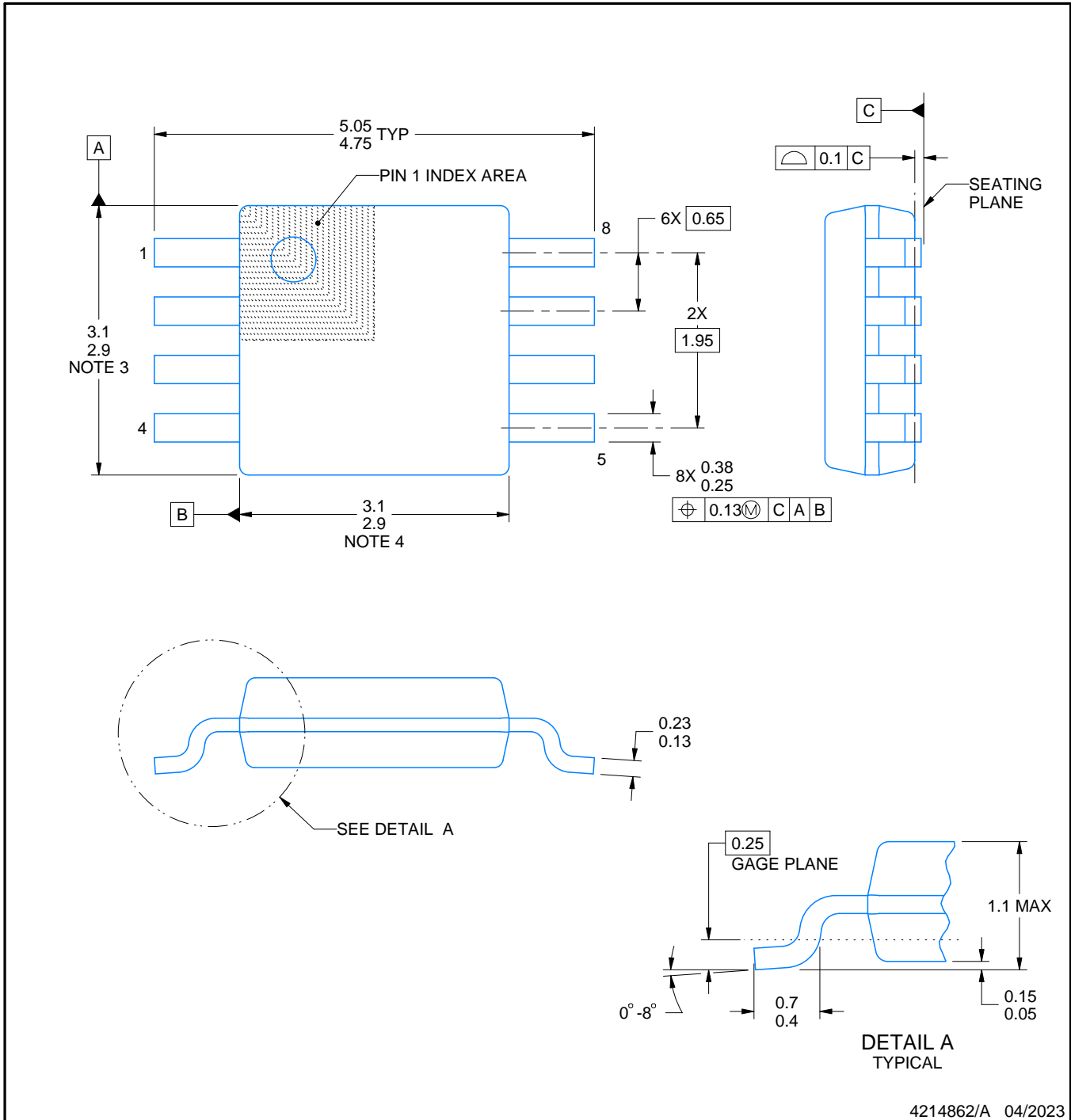
# DGK0008A



# PACKAGE OUTLINE

## VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



4214862/A 04/2023

**NOTES:**

PowerPAD is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.

# EXAMPLE BOARD LAYOUT

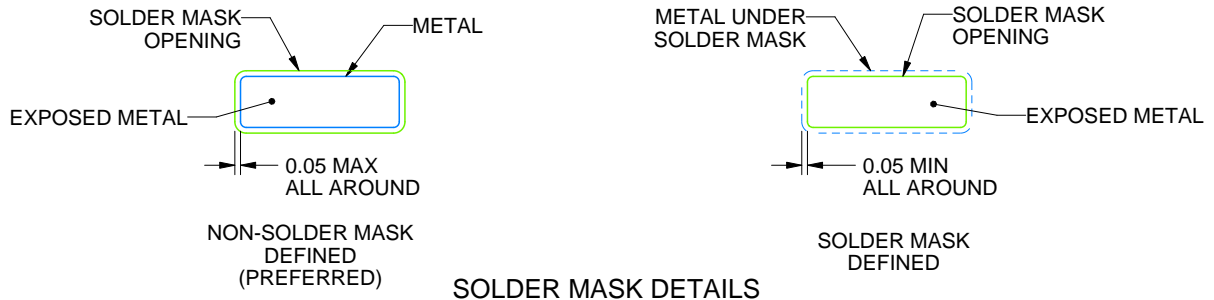
DGK0008A

™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 15X



SOLDER MASK DETAILS

4214862/A 04/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

# EXAMPLE STENCIL DESIGN

DGK0008A

<sup>TM</sup> VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
SCALE: 15X

4214862/A 04/2023

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.

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最后更新日期：2025 年 10 月